

6. Potential Pitfalls

Andy Bushby

Potential pitfalls

- Non-ideal tip shape (not perfect sphere or pyramid)
- Thermal drift or mechanical instability
- Non-ideal surface (not perfectly smooth and flat)
- Non-ideal material response (creep, pile-up, etc.)
- Size effects (changes in material properties with scale)

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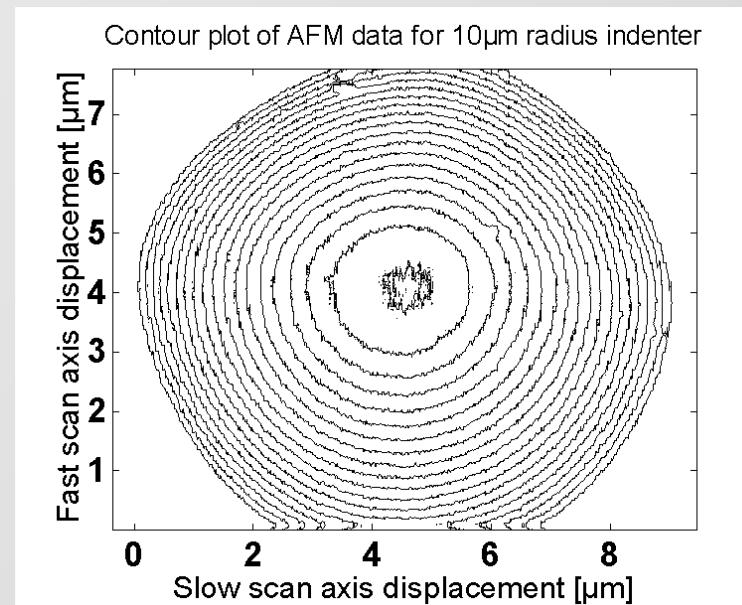
Non-ideal tip shape:

Contact mechanics relies on a knowledge of the indenter tip shape

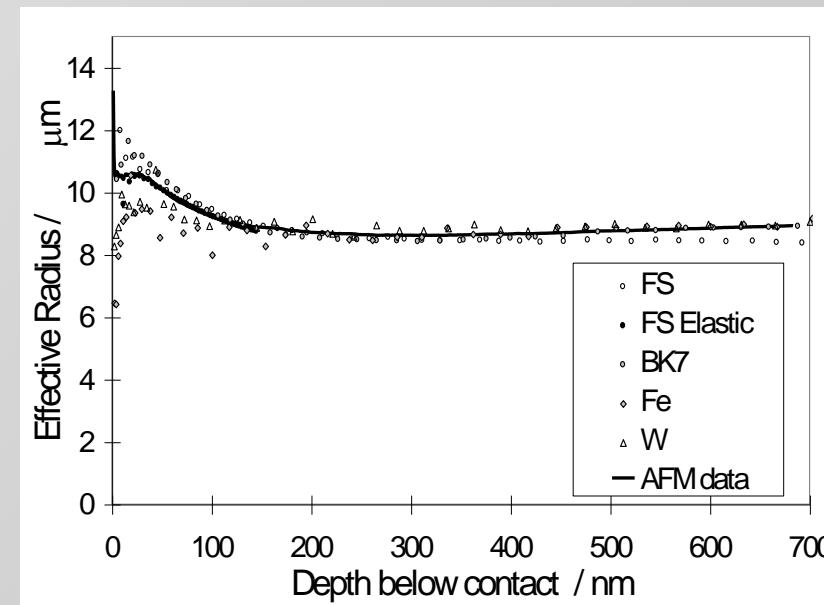
Indentation Golden Rule #1. – you **MUST** know your tip shape!

Calibrate your indenter tip shape !!!

Direct method – AFM



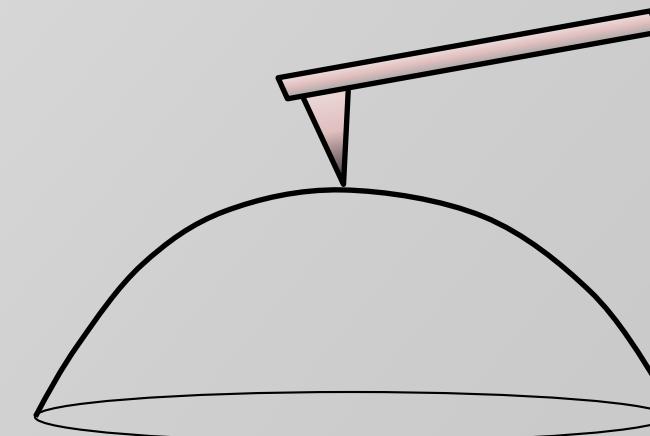
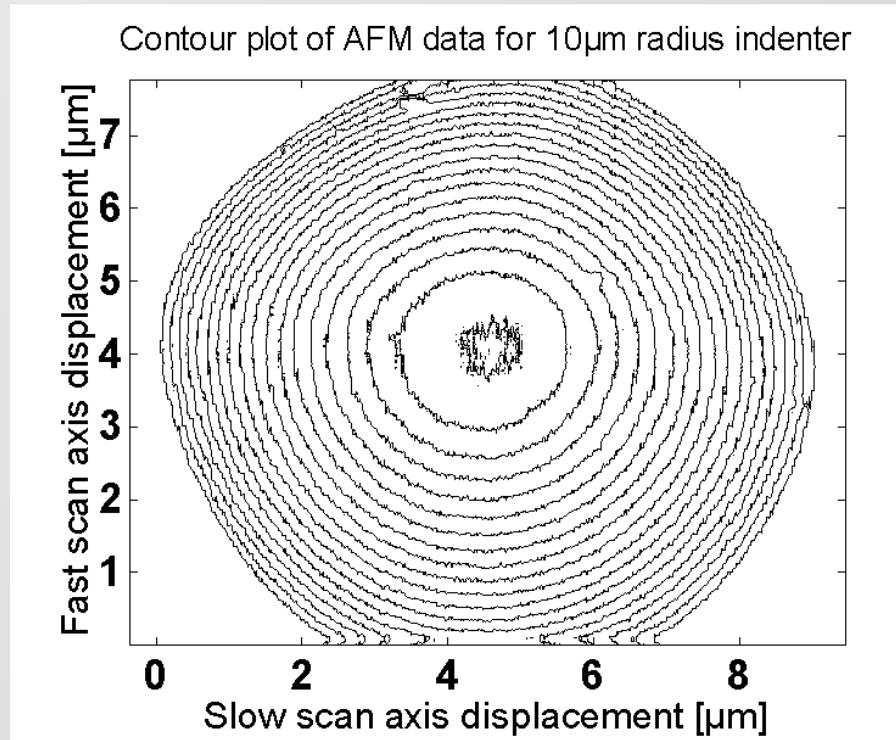
Indirect method – reference materials



Metrological AFM to measure shape directly

3D image of indenter tip

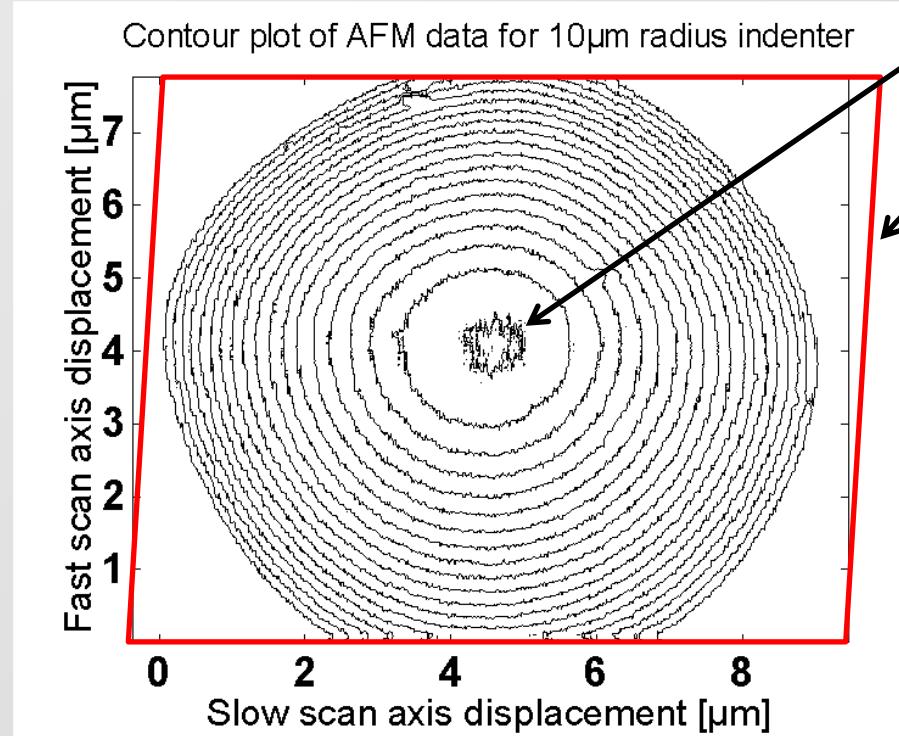
Area at know distance from the top



Metrological AFM to measure shape directly

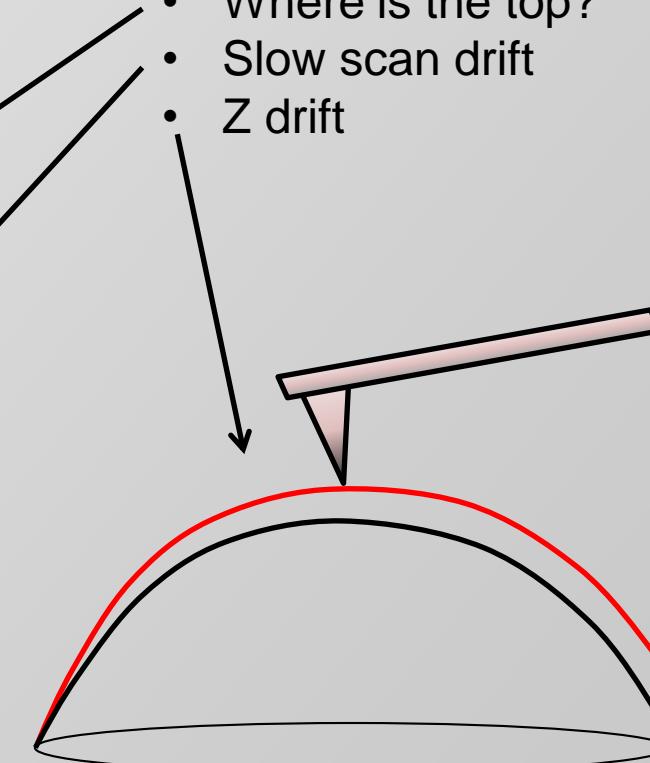
3D image of indenter tip

Area at know distance from the top



Problems:

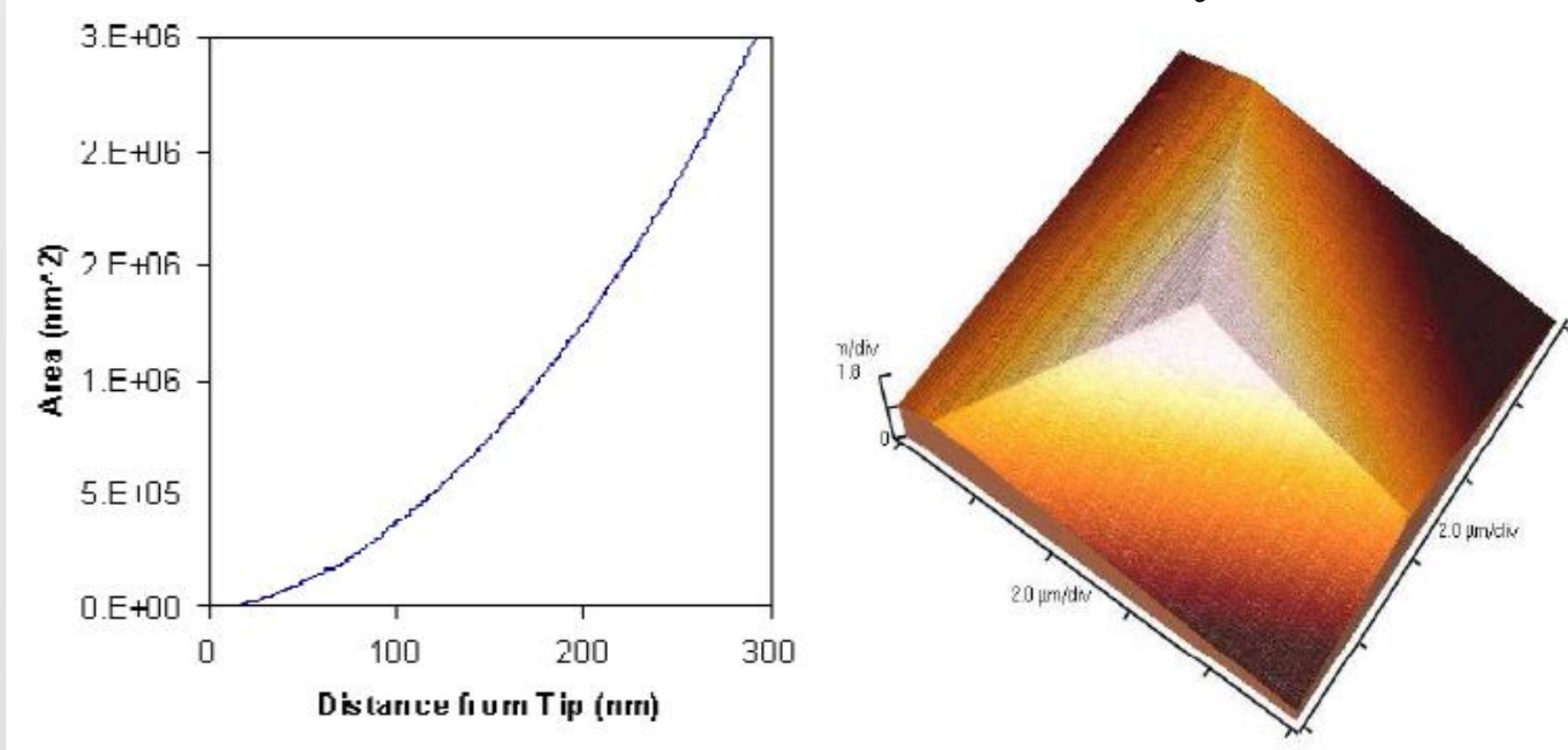
- Where is the top?
- Slow scan drift
- Z drift



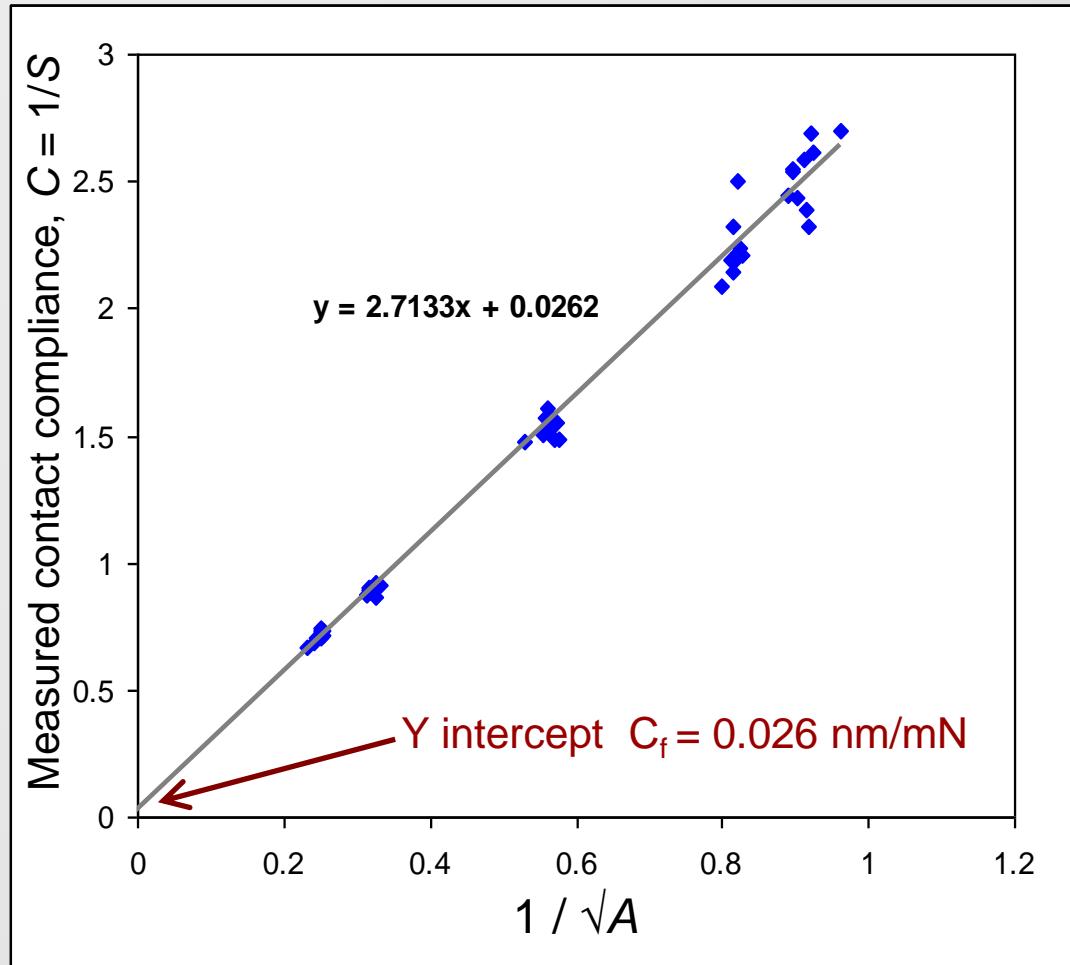
Non-ideal tip shape: Calibration: Direct measurement with AFM

Berkovich 3 sided pyramid

For ideal Berkovich indenter
Area = $A = 24.56 h_c^2$



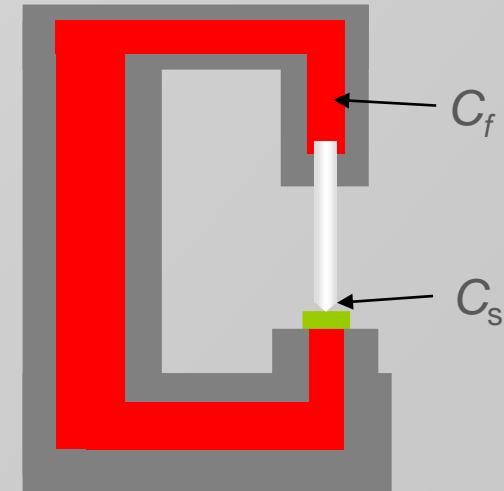
Indirect method – contact compliance



The **measured contact compliance** ($1/S$) is the sum of the contact compliance between indenter and sample, C_s , and the frame compliance, C_f

$$C = C_f + C_s$$

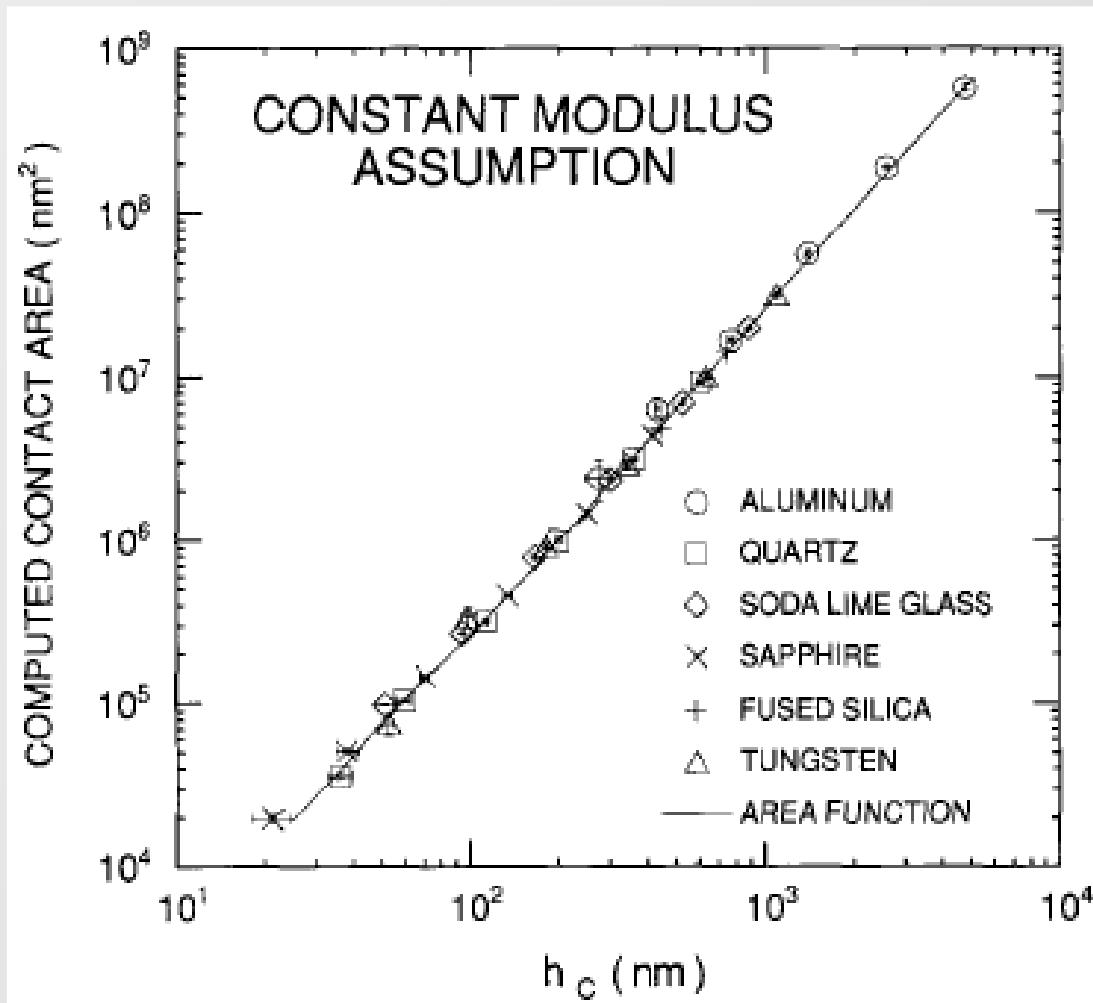
$$C = C_f + \frac{\sqrt{\pi}}{2E_r} \cdot \frac{I}{\sqrt{A}}$$



A plot of C vs $A^{-1/2}$ should be linear (constant E with depth) and has C_f as the intercept on the y-axis

However, this assumes you already know A vs h_c

Indirect method – contact compliance



$$A = 24.5h_c^2$$

$$A = \frac{\pi}{4} \frac{1}{E^{*2}} \frac{1}{(C - C_f)^2}$$

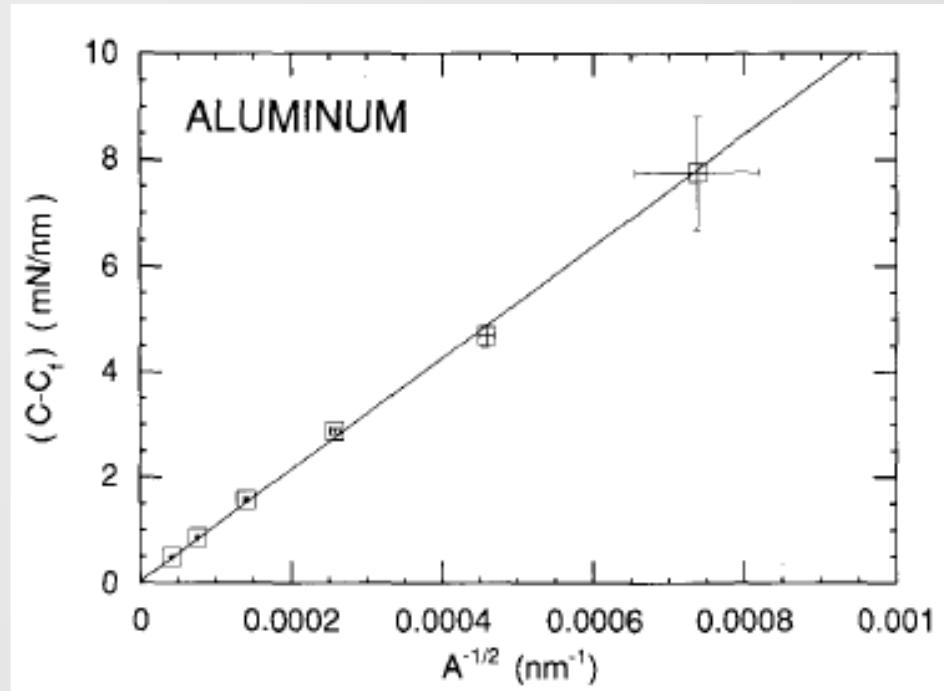
E^* and C_f are estimates

A vs h_c is plotted and fitted with: -

$$A = 24.5h_c^2 + C_1h_c^1 + C_2h_c^{1/2} + C_3h_c^{1/4} + \dots + C_8h_c^{1/128}$$

The process is iterated to obtain better estimates of E^* and C_f

Indirect method – contact compliance



Finally, a plot of $C - C_f$ vs $A^{-1/2}$ should be linear (constant E with depth) with a zero intercept on the y-axis

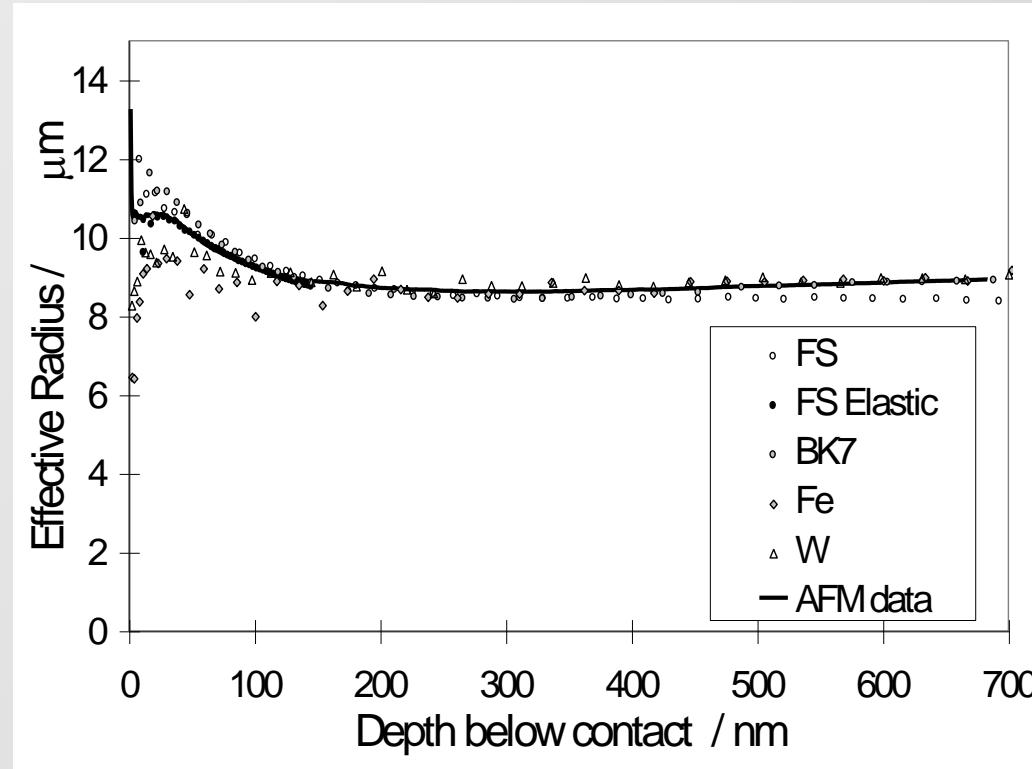
$$C - C_f = \frac{\sqrt{\pi}}{2E_r} \cdot \frac{I}{\sqrt{A}}$$

This should be done for several reference materials – NOT JUST ONE

Multiple reference material method

Indent into (**several**) materials with known elastic moduli

Using only one reference material is not good enough



Chose materials:

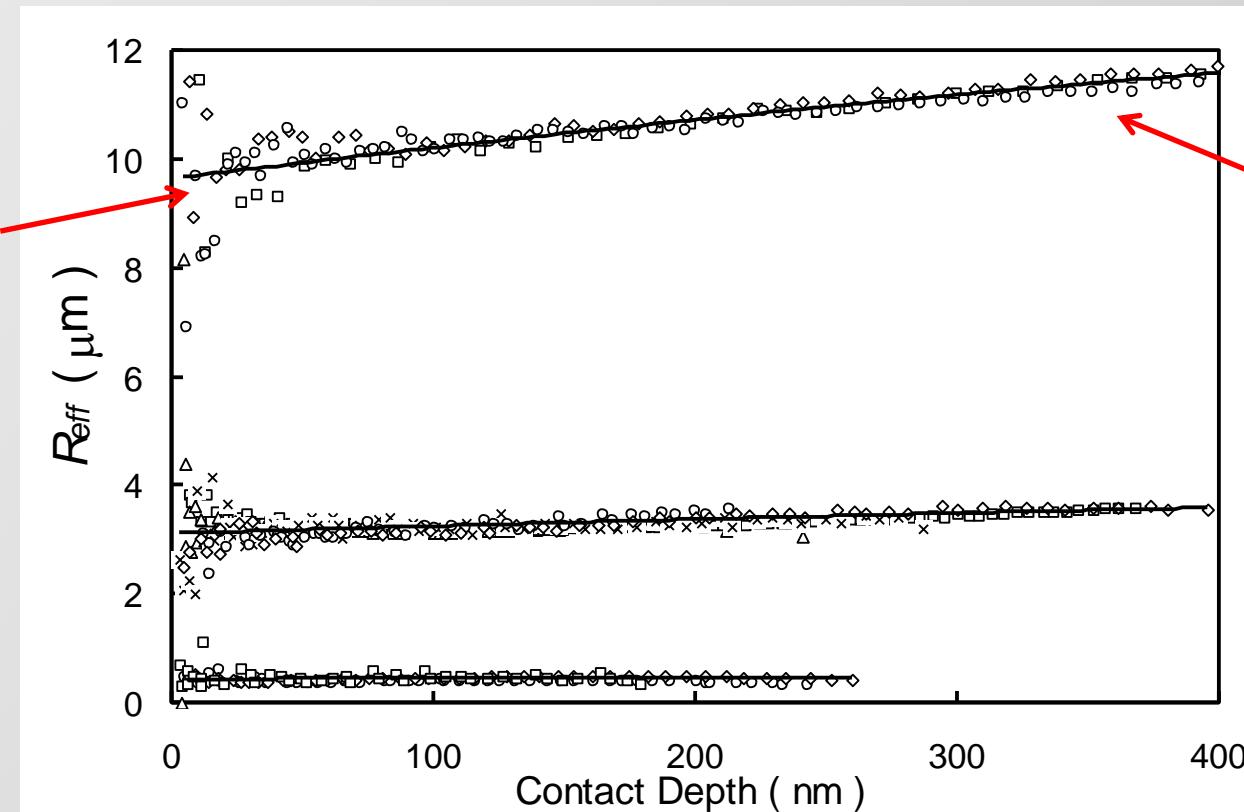
- Wide range of modulus
- High hardness
- Homogeneous and isotropic
- Hertz equation, solve for R

$$R^* = \left(\frac{9}{16} \frac{F^2}{E^{*2}} \frac{1}{h_e^3} \right)$$

Non-ideal tip shape: Calibration: effective radius vs depth of contact

Low loads:
sensitive to material &
indenter modulus E^*

High loads:
sensitive to
frame stiffness C_f



$$E^* = 36.8 \text{ GPa}$$

$$E^* = 70.5 \text{ GPa}$$

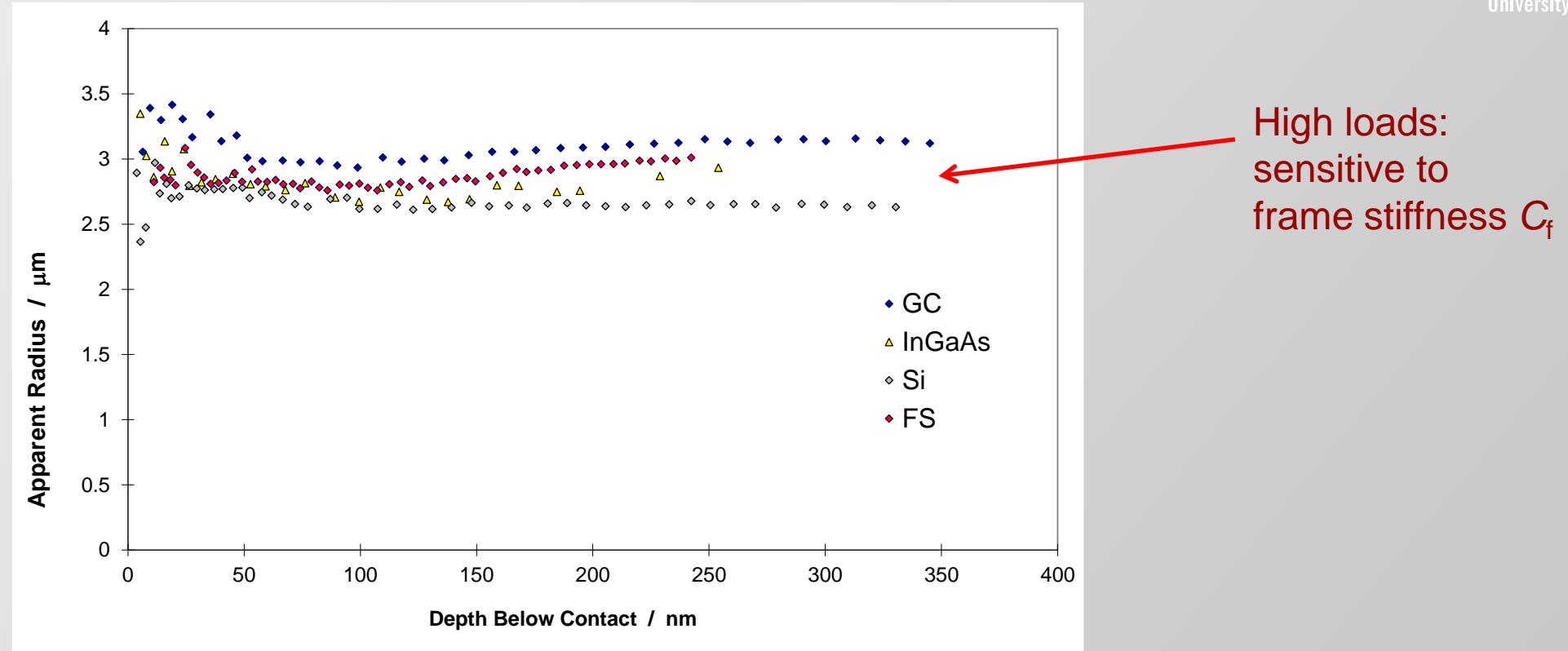
$$E^* = 150 \text{ GPa}$$

$$E^* = 300 \text{ GPa}$$

□ Glassy Carbon, ◇ Fused Silica ○ Si (001) × Tungsten,

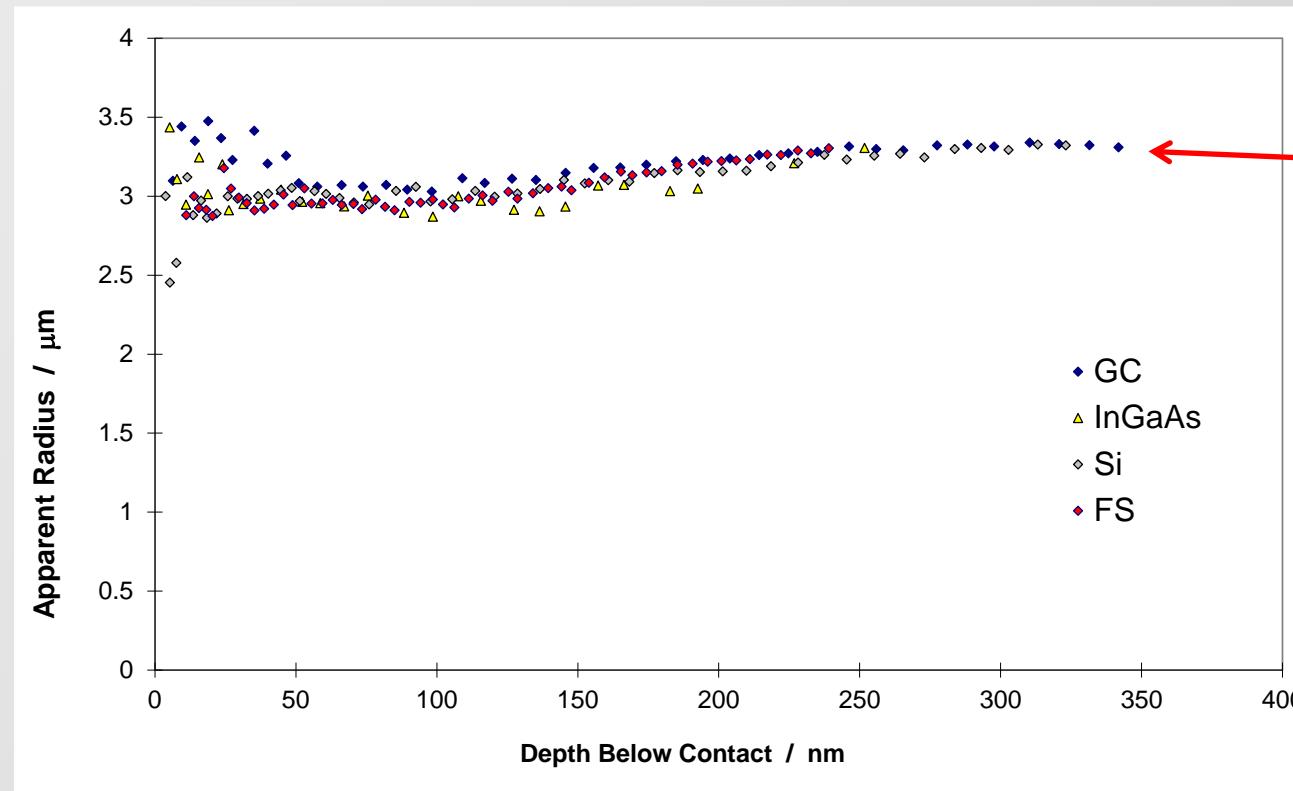
R_{eff} is a function of h_c , and $C_f = 0.24 \text{ mm/mN}$.

Non-ideal tip shape: Calibration: effective radius vs depth of contact



Wrong frame compliance value

Non-ideal tip shape: Calibration: effective radius vs depth of contact

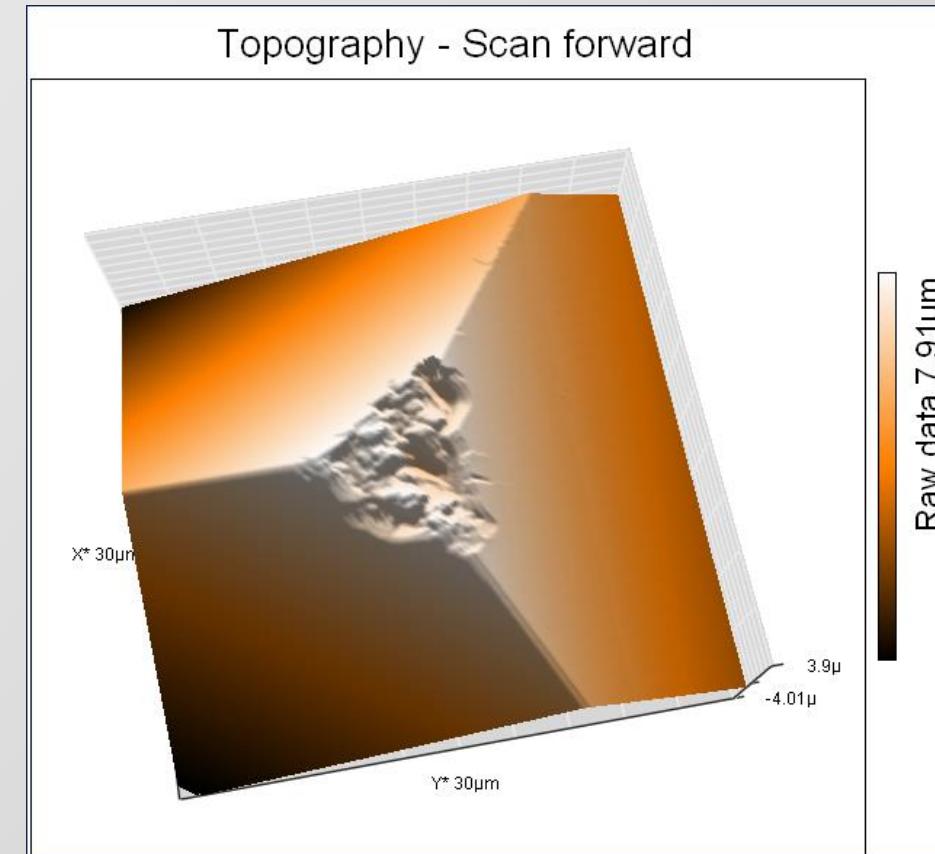


High loads:
sensitive to
frame stiffness C_f

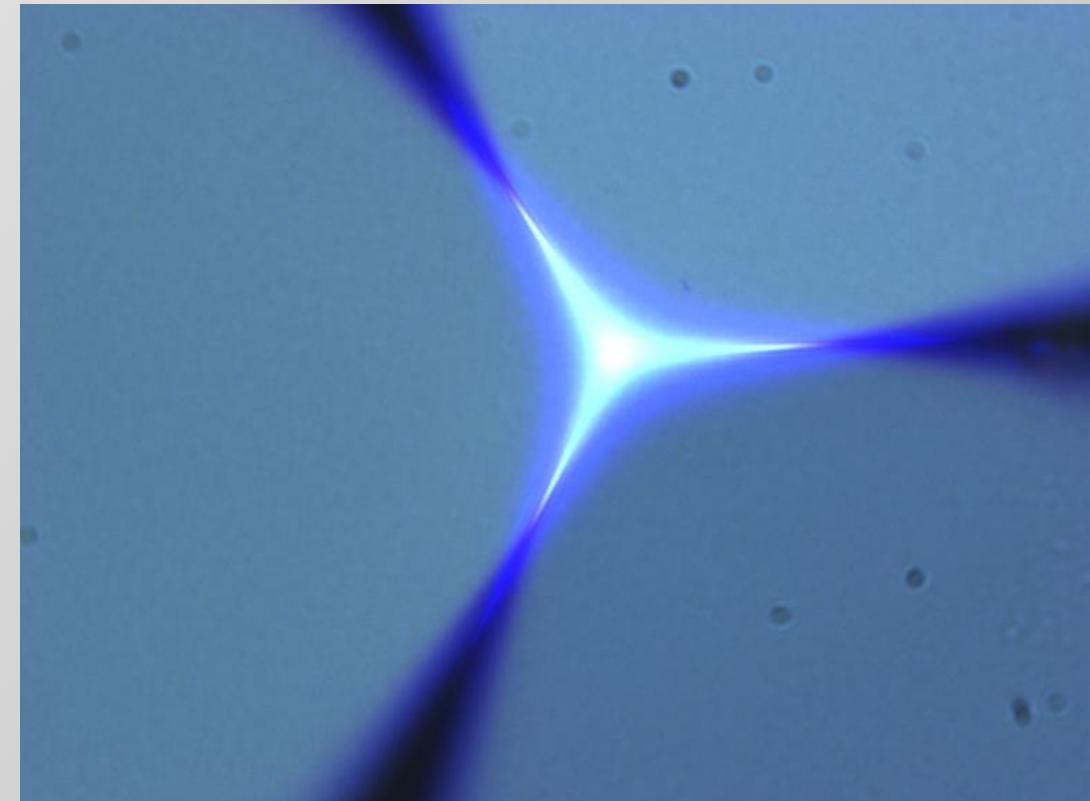
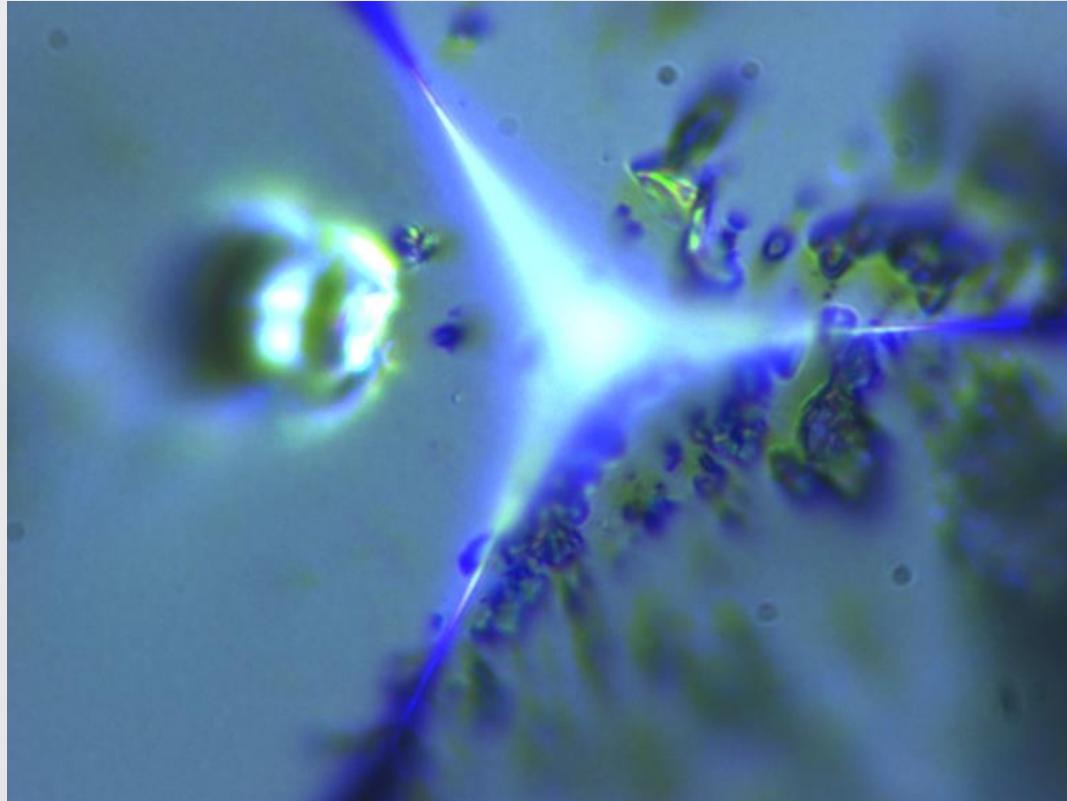
Correct frame compliance value

Non-ideal tip shape: Example of damaged tip

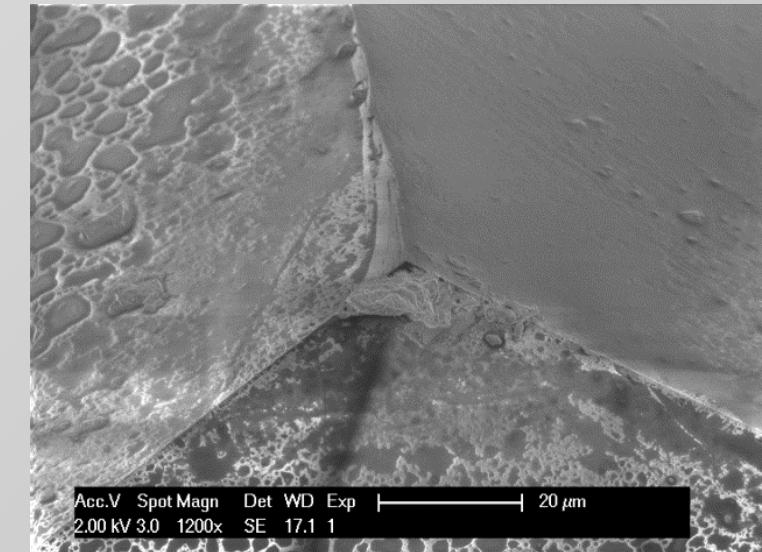
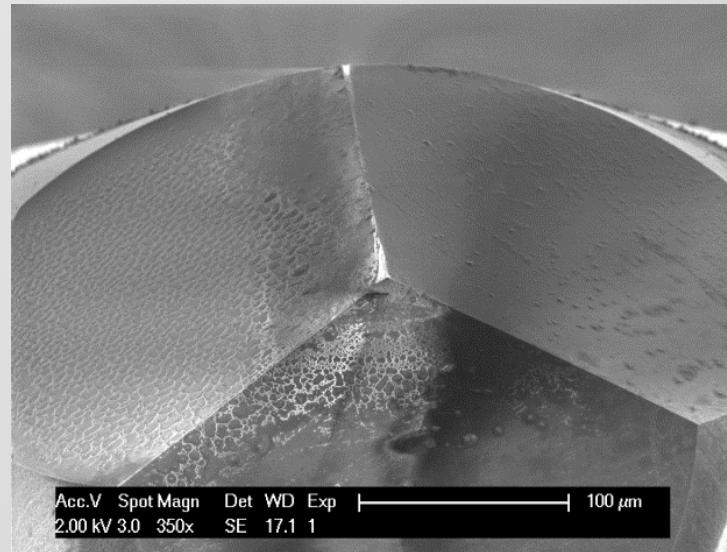
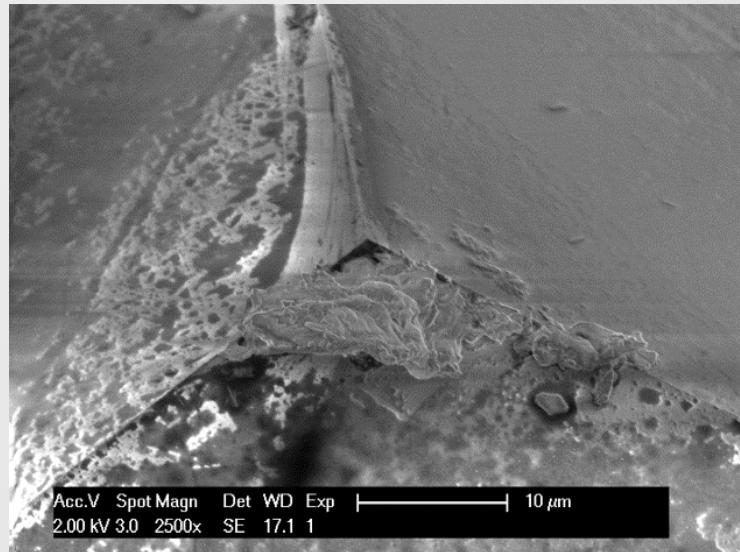
Berkovitch 3 sided pyramid



Cleaning with isopropanol, compressed air

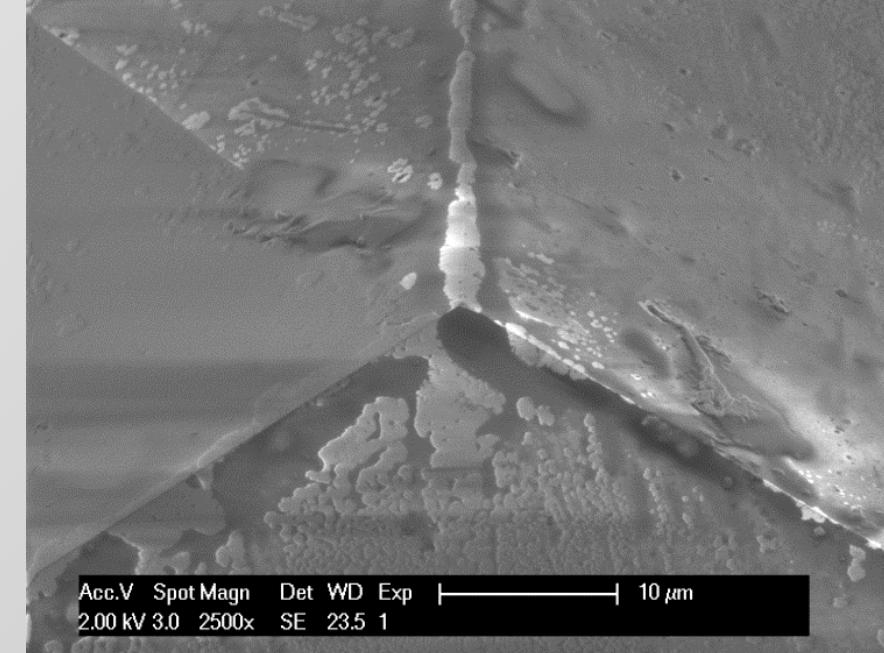
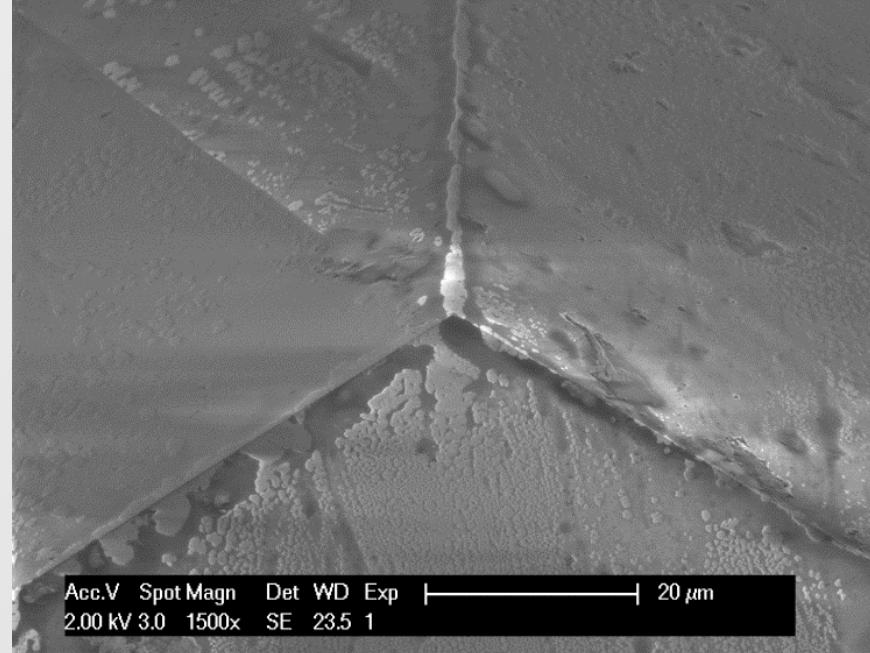


Cleaning with isopropanol, compressed air



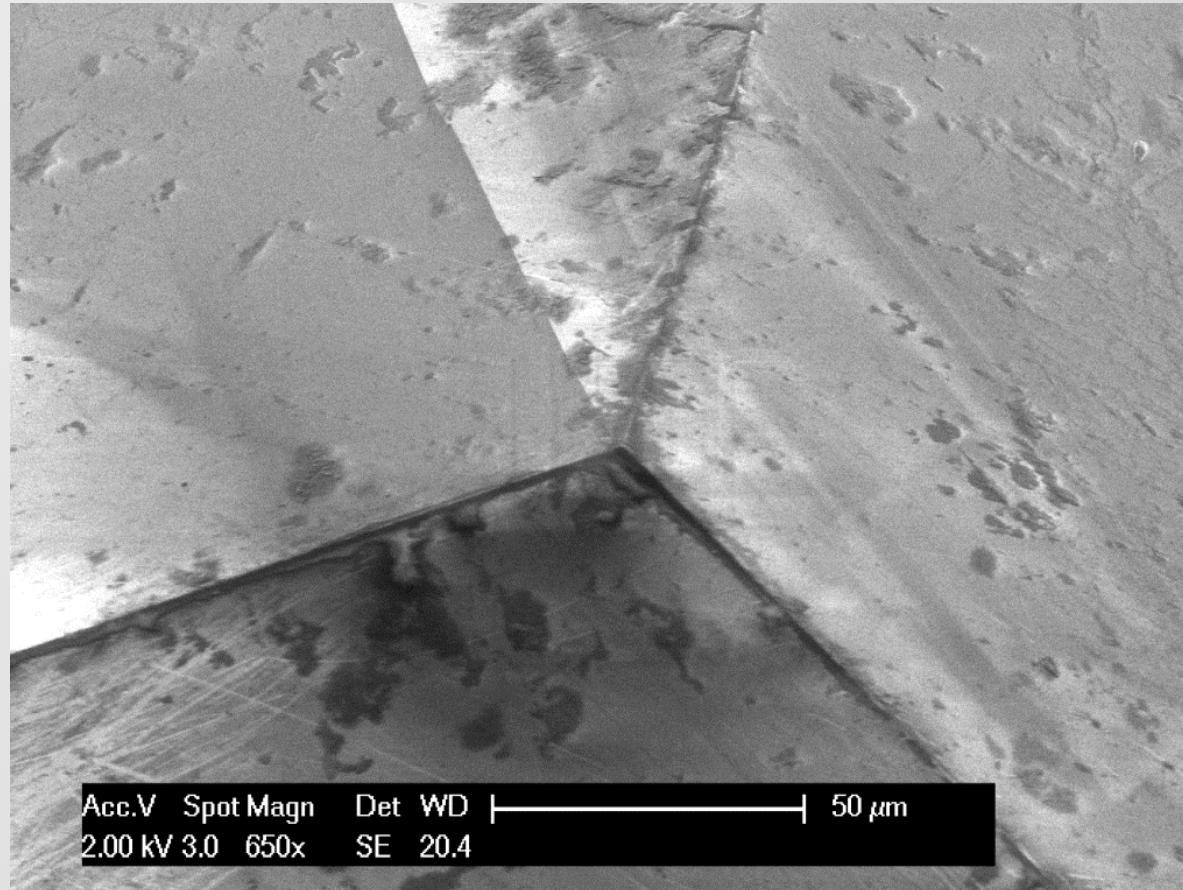
Cleaning with isopropanol, compressed air.... but still some residue!

Is the compressed air source clean? i.e., no oil from the compressor?



More cleaning with isopropanol, compressed air.... now better:

Queen Mary
University of London

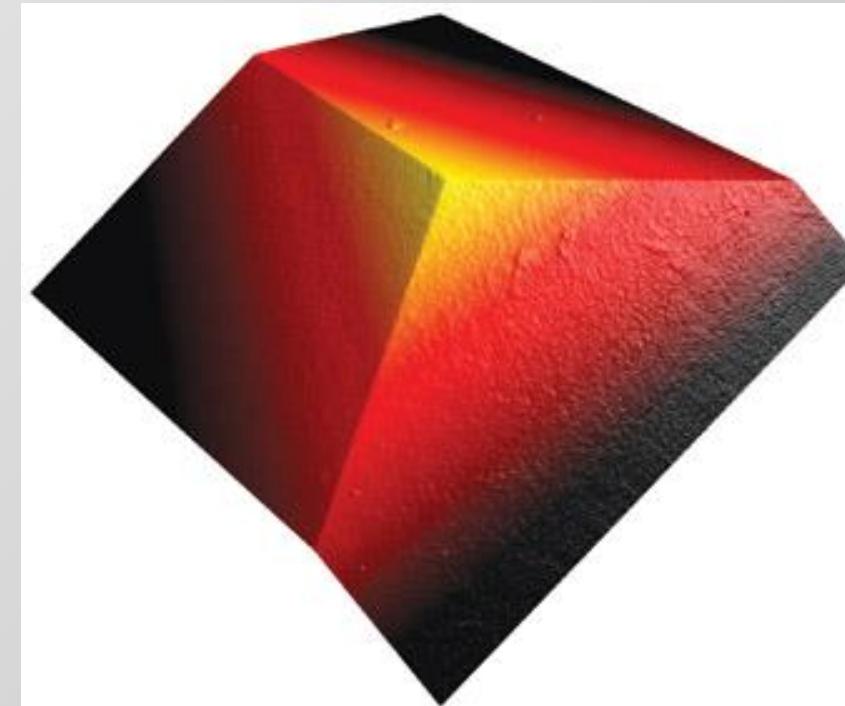
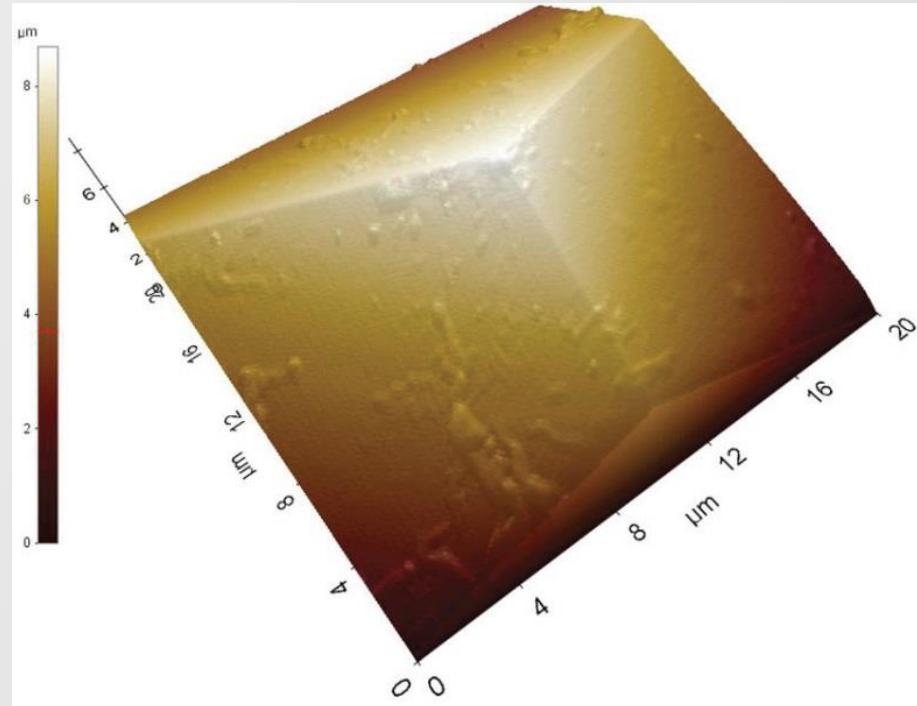


If indenter seems contaminated, proceed as follows:

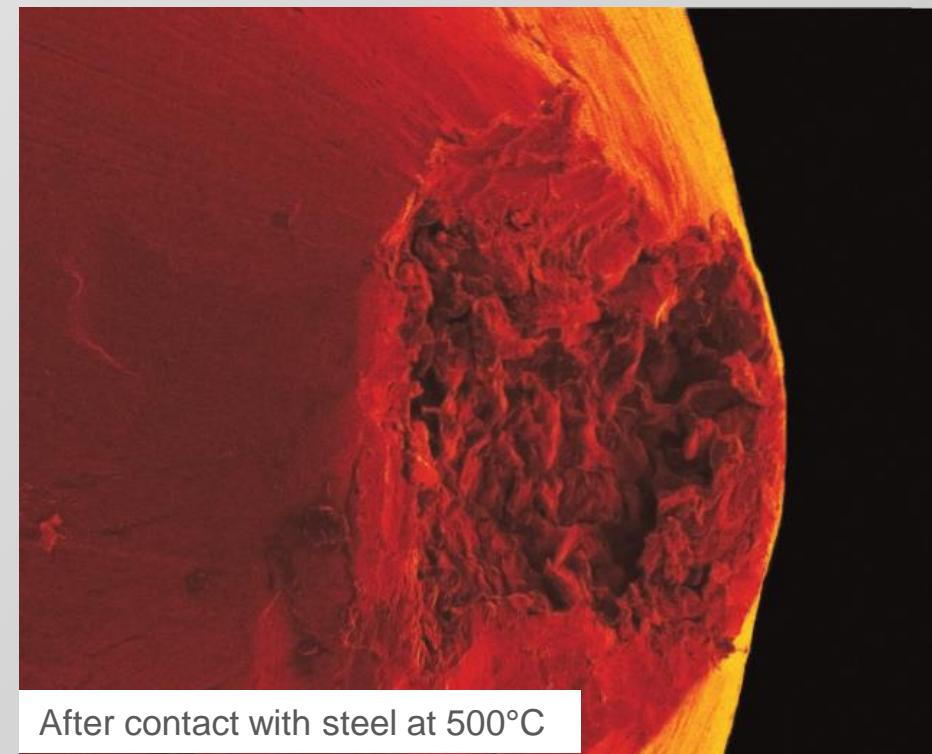
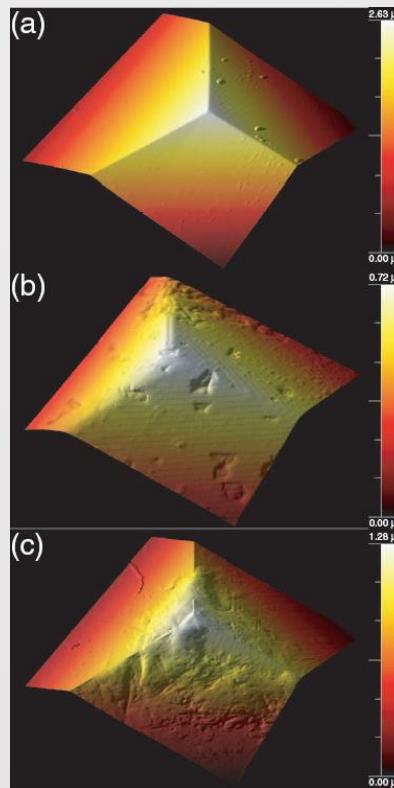
1. Looking at the apex through an optical microscope, gently rub the diamond with a cotton bud soaked in isopropanol
2. Turn the cotton bud around and use the dry end to wipe off any excess solvent. Then blow off immediately with compressed air.
3. **IMPORTANT:** Do not use ultrasonic cleaning machines as this technique may loosen the braize holding the indenter



AFM can be used to check cleanliness and geometry (if calibrated)

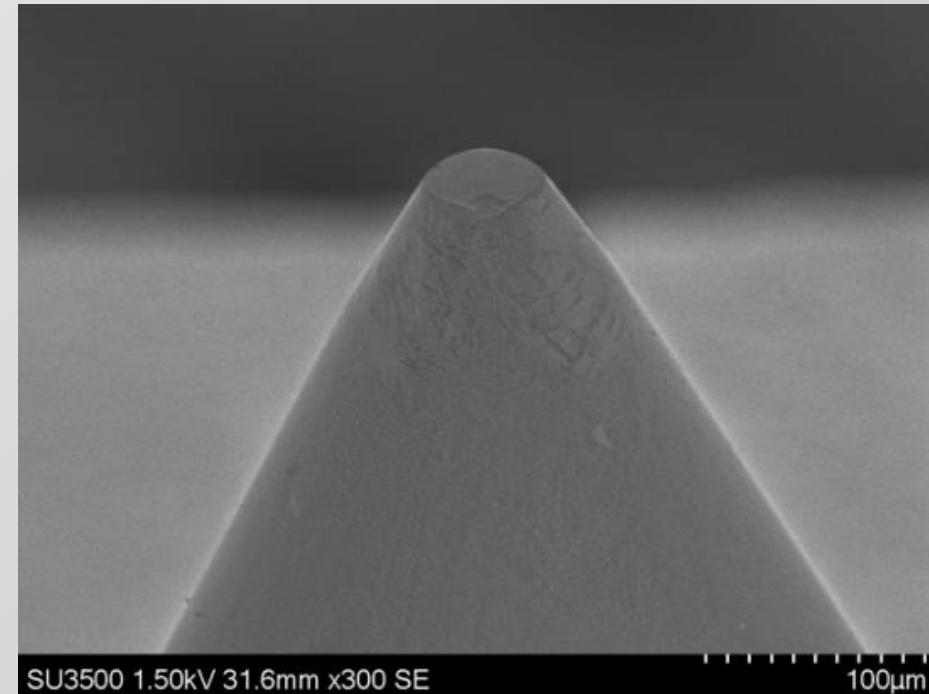
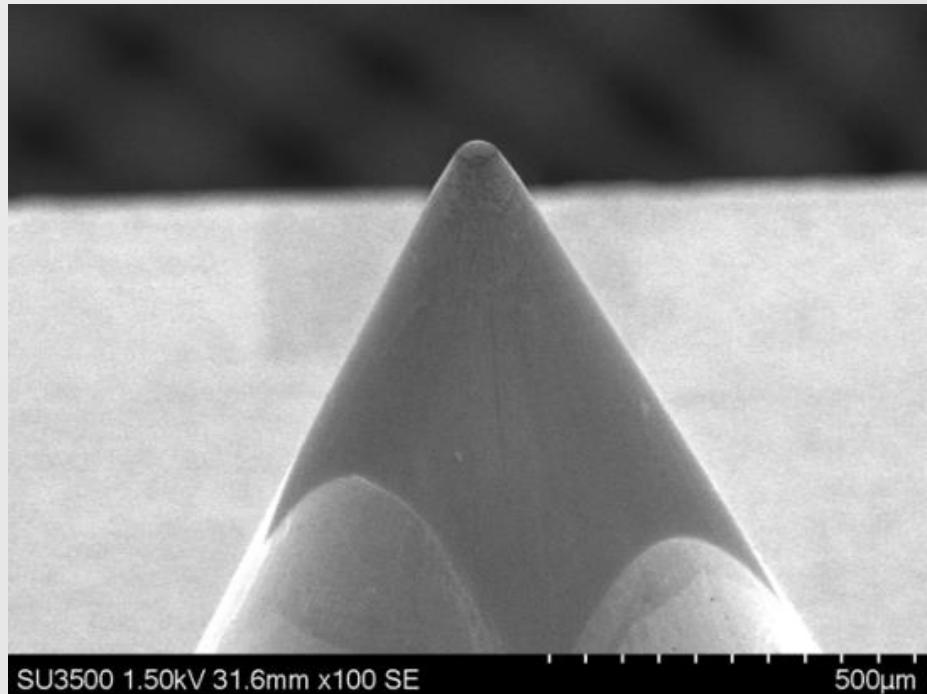


Diamond oxidises $> 400^{\circ}\text{C}$ and can react chemically with C-containing materials



How good is your flat punch indenter..?

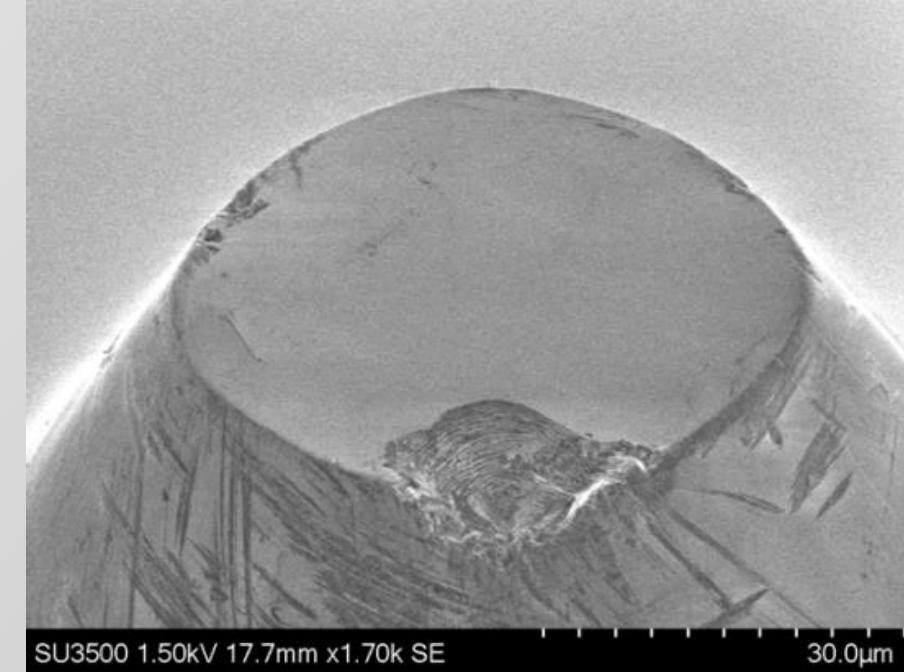
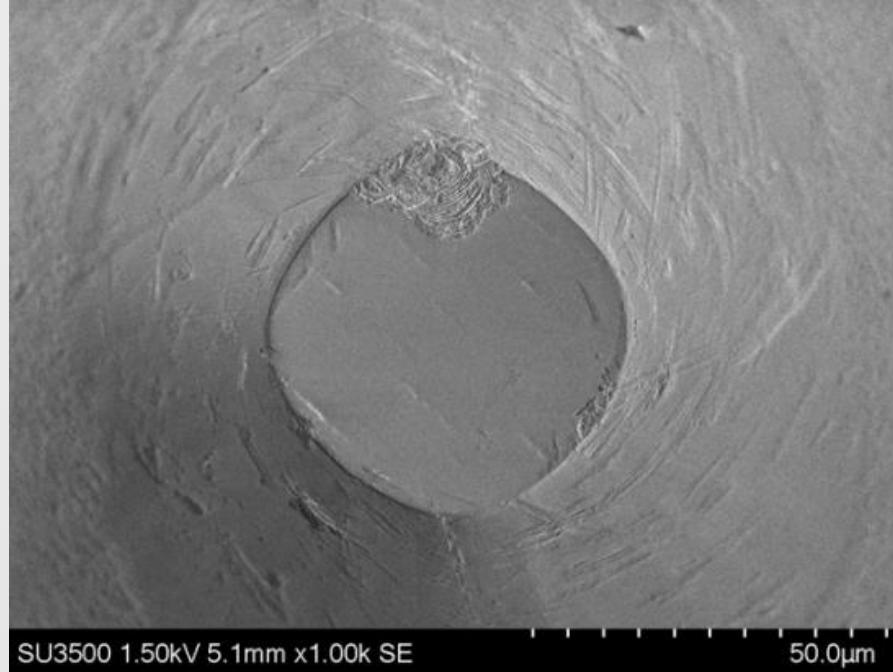
Is the reality what the manufacturer specified?
Taper angle, sphericity, polish, etc...



How good is your flat punch indenter..?

This indenter was supposed to be 50 µm diameter but is actually significantly less.

The spherical part is non-perfect and has a bad defect!



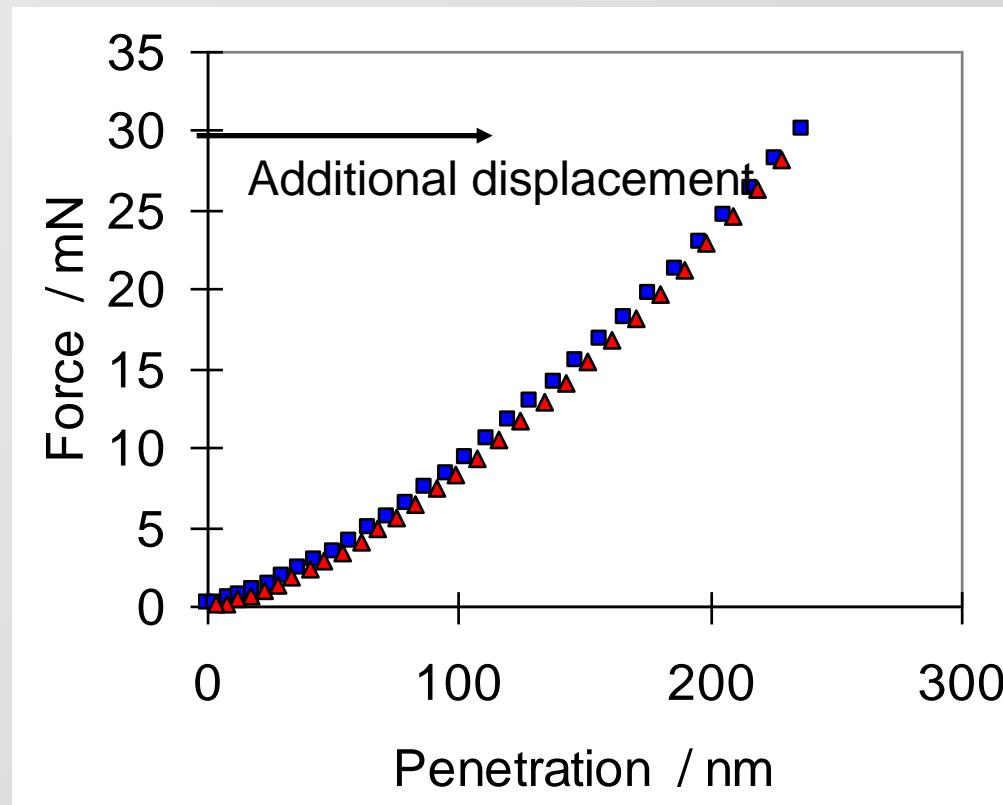
Potential pitfalls

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Indentation Golden Rule #2 – you **MUST** know your instrument characteristics

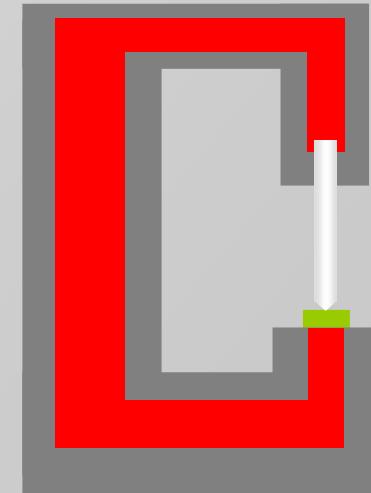
Frame compliance:

When the surface is loaded there is a reaction force in the instrument frame that causes a deflection proportional to load, making the material appear to be more compliant (less stiff)



$$h = C_f F + h_m$$

C_f is a constant $\sim 0.2 \text{ nm/mN}$



Instrument stability – thermal drift:

Adds to displacement measurement as a function of time

316 Stainless steel CTE $16\mu\text{m}/\text{m K}$ so 100mm shaft, for 0.01°C change in $T = 16\text{nm}$ displacement

Measure a 5mm thick sample of Copper to depth of about 1000nm,
Copper CTE $16.6 \mu\text{m}/\text{m K}$, 0.01°C rise in $T = 0.17\text{nm}$ change in thickness

Total thermal expansion = 16.2nm = error $\sim 1.6\%$

Measure a 5mm thick sample of FS to depth of about 100nm,
FS CTE $5.9 \mu\text{m}/\text{m K}$, 0.01°C rise in $T = 0.3\text{nm}$ change in thickness
Total thermal expansion = 16.3nm = error $>16\%$

Measure a 10mm thick sample of PMMA to depth of about 100nm,
PMMA CTE $75 \mu\text{m}/\text{m K}$, 0.01°C rise in $T = 7.5\text{nm}$ change in thickness
Total thermal expansion = 23.5nm = error $>23\%$

(Reduce the measurement path to 1mm, expansion of machine $<< 1\%$)

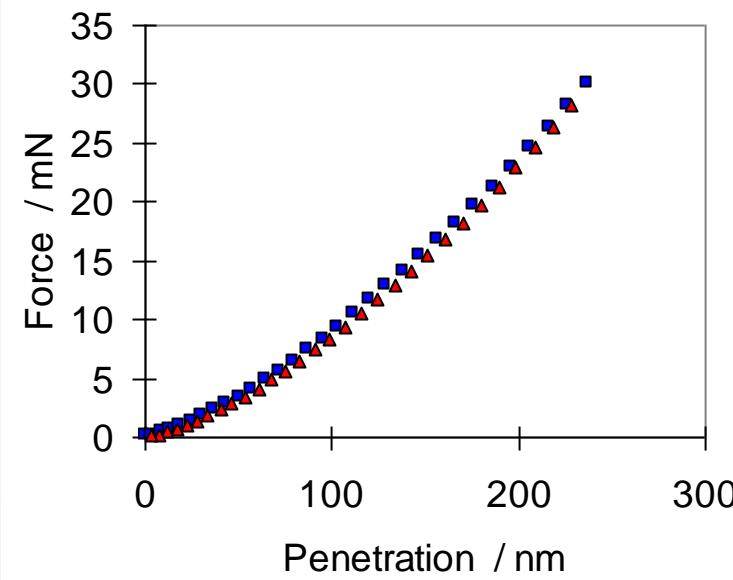
Instrument stability – thermal drift:

Adds to displacement measurement as a function of time

$$h_t = 220\text{nm}$$

$$h_e = 220\text{nm}$$

$$h_c = 110\text{nm}$$



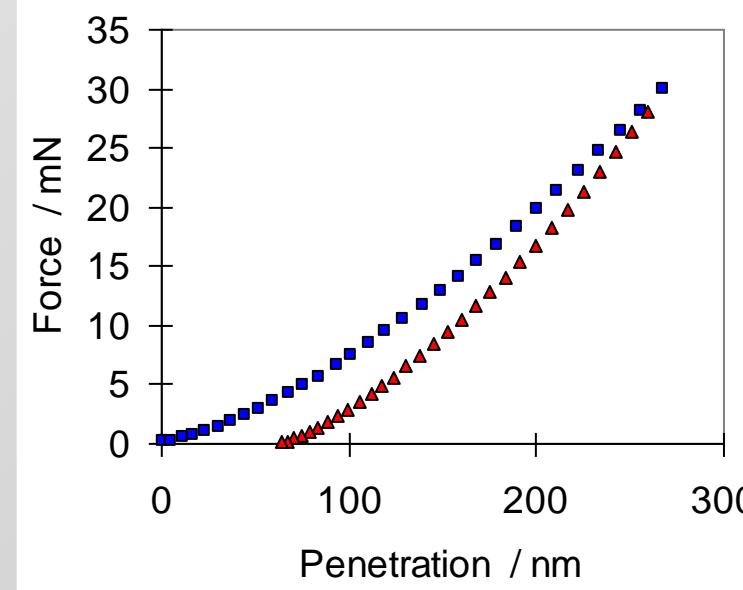
Elastic – no thermal drift

$$h_t = 265\text{nm}$$

$$h_e = 200\text{nm}$$

$$h_c = 165\text{nm}$$

$$\begin{matrix} E^* \uparrow \\ H \downarrow \end{matrix}$$

Error in contact area $\propto h_c^2$ Elastic with thermal drift
 $\sim 0.3\text{nm/s}$

Potential pitfalls

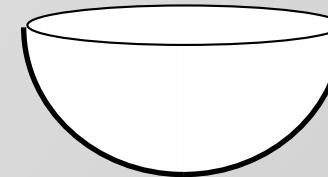
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Indentation Golden Rule #3 – you **MUST** know your sample characteristics

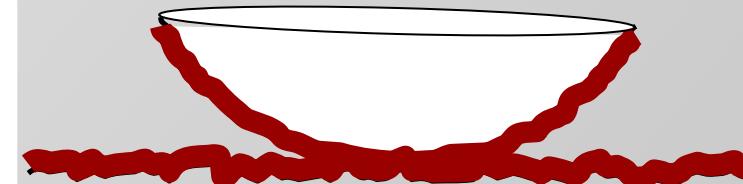
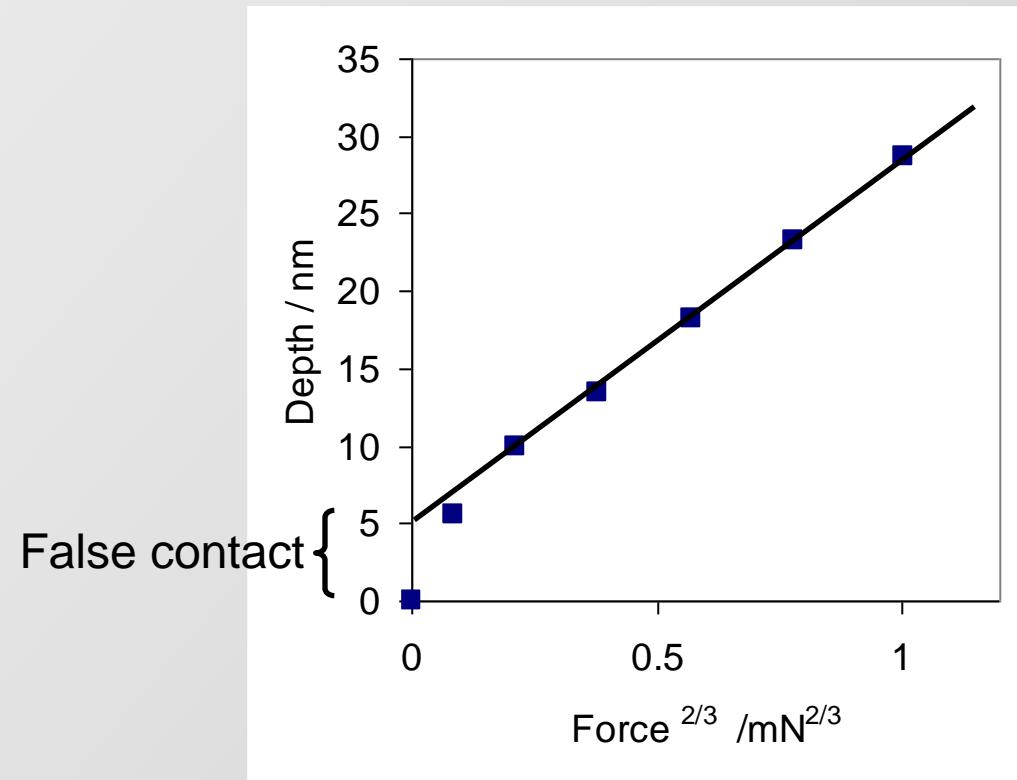
Surface roughness:

On indenter and test material

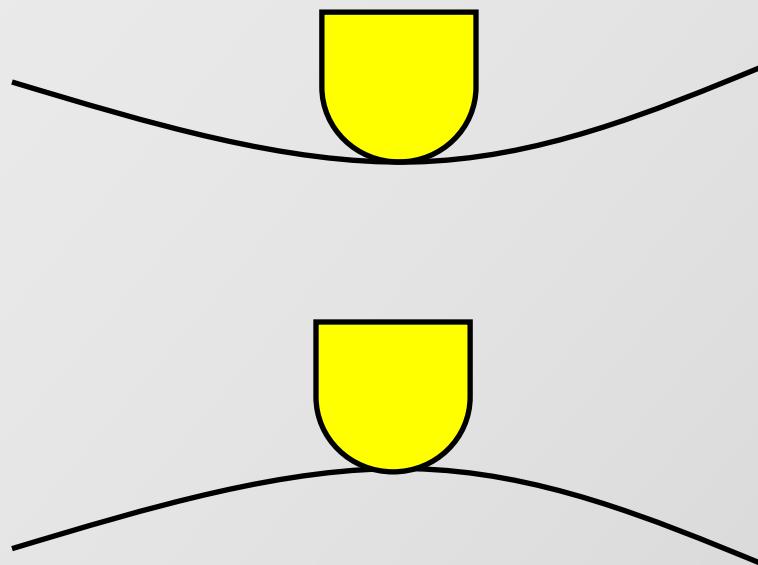
Determining surface contact difficult



Theory

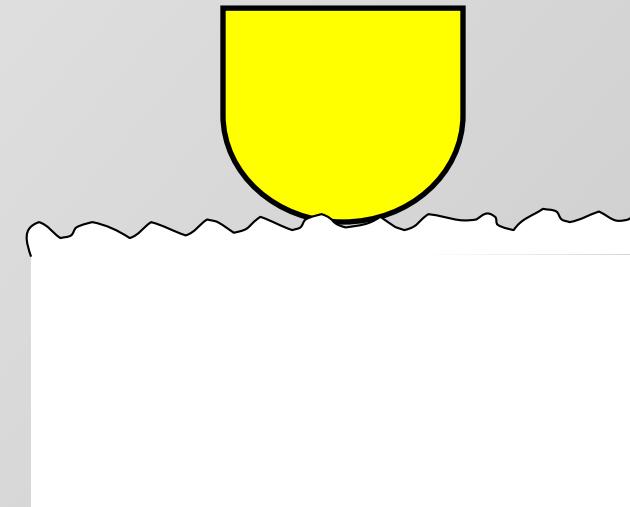


Reality

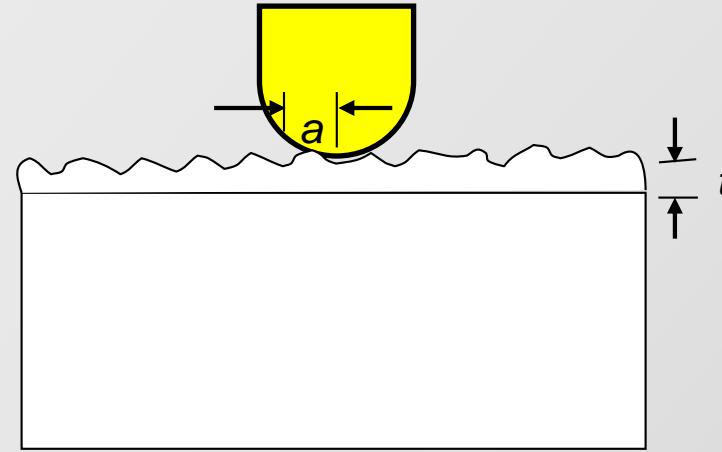


General curvature $> 10R$
 $< 5\%$ error in E

General curvature $> 100R$
 $< 0.5\%$ error in E

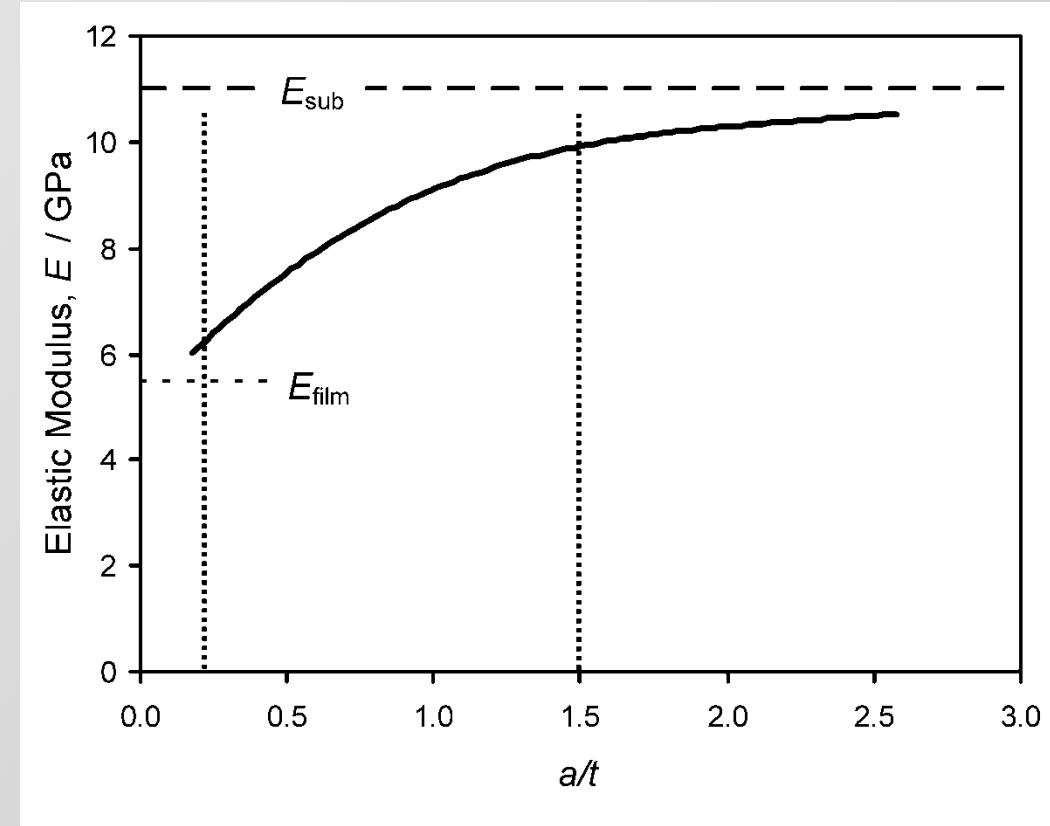


Surface roughness much shorter period than indenter tip radius: –
treat as layer on a substrate



Soft layer on the bulk

Continuously changing modulus with depth



At $h < 2 \times$ roughness the influence of roughness is significant

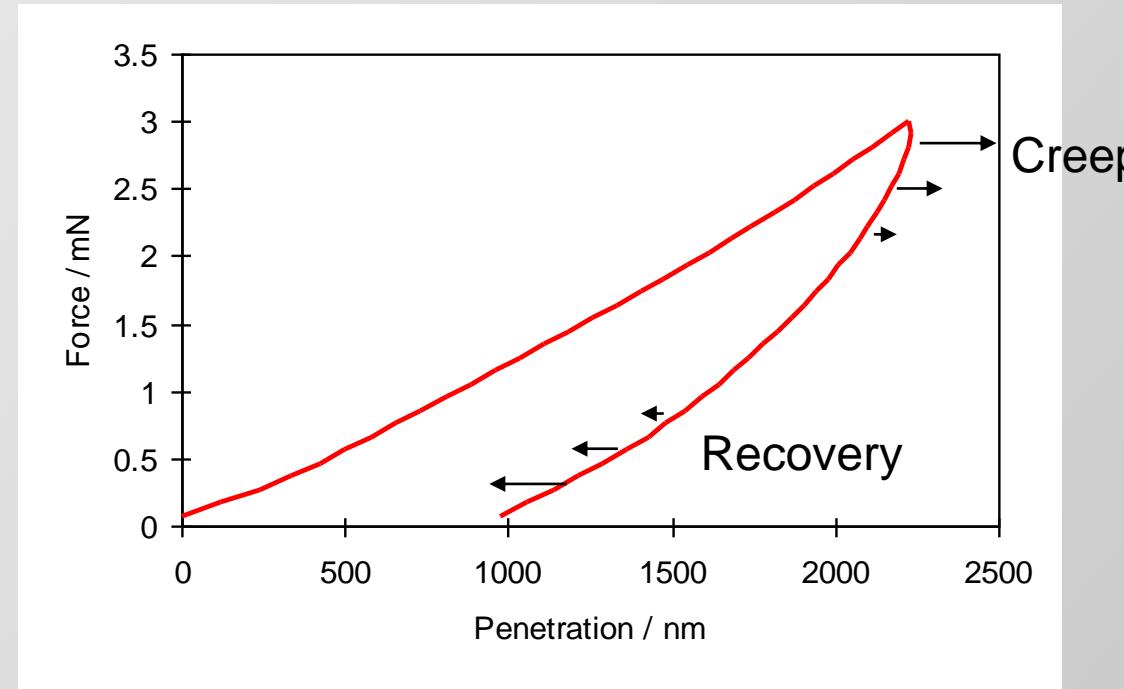
At $h > 10 \times$ roughness the influence of roughness is insignificant

Potential pitfalls

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Creep:

Can distort unloading slope and the fitting of the unload curve
Over estimating the gradient – overestimating E and underestimating H

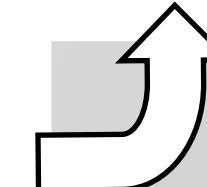
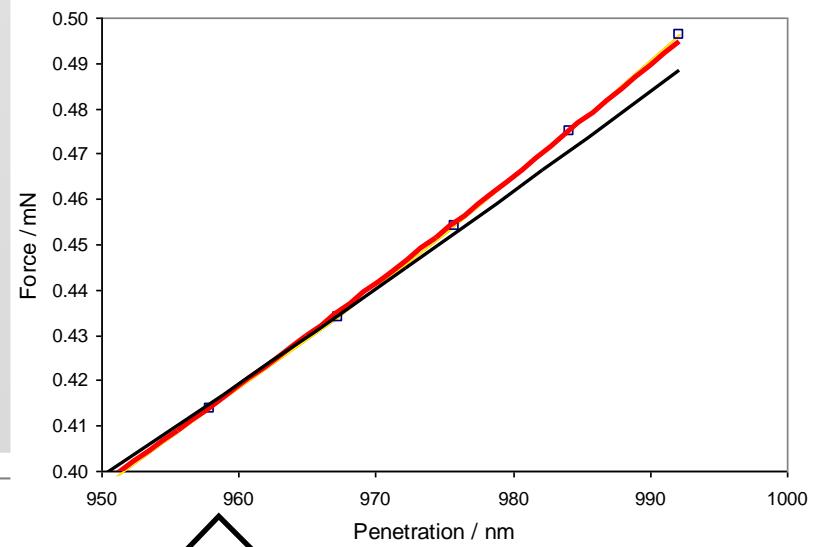
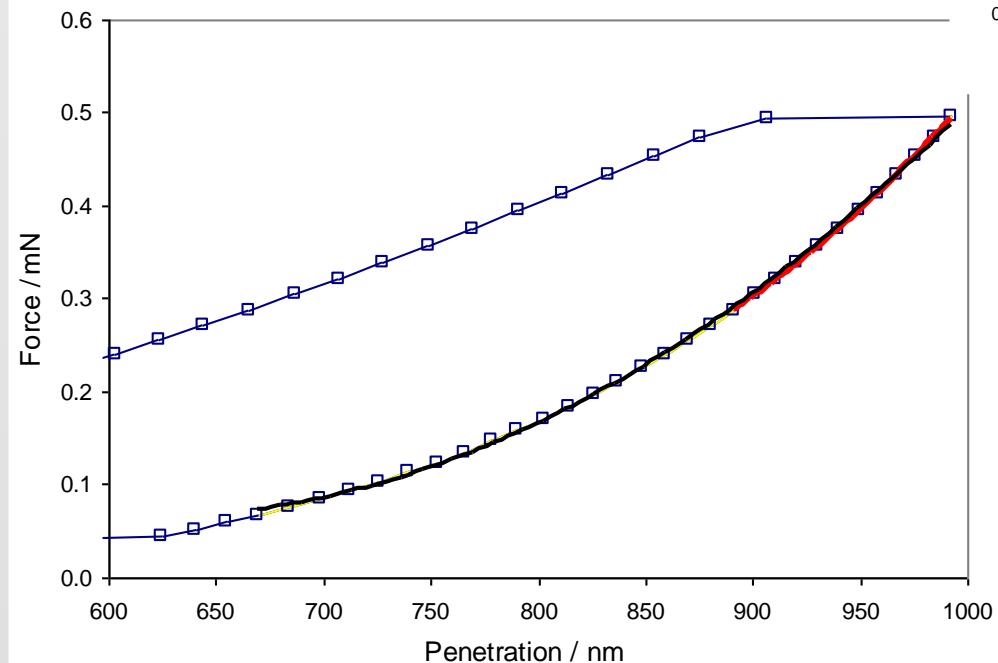


Creep during unloading

Fit to unload curve:

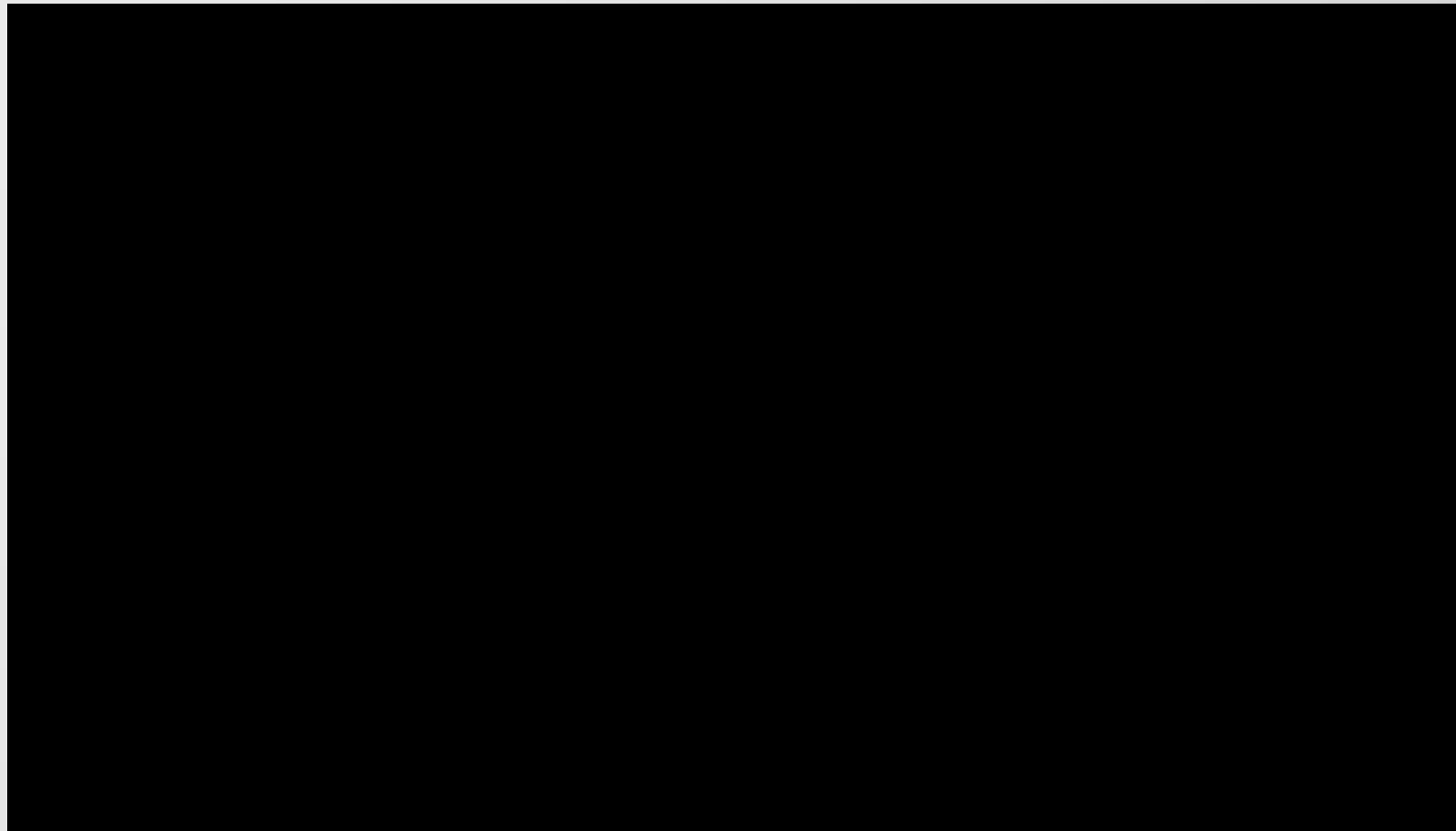
Poor fitting can distort unloading slope

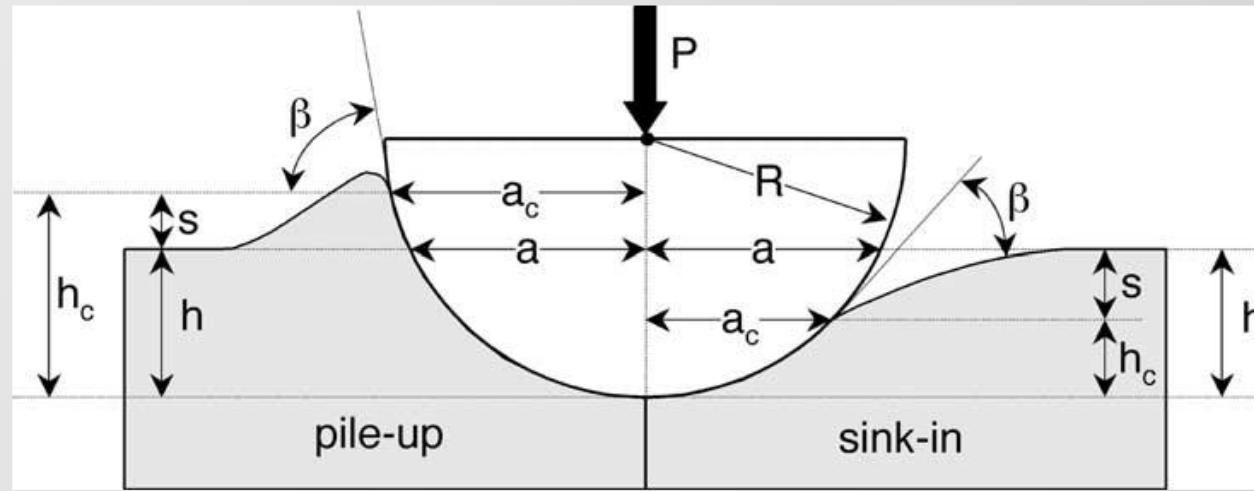
A regression fits best in the middle
and worst at the ends



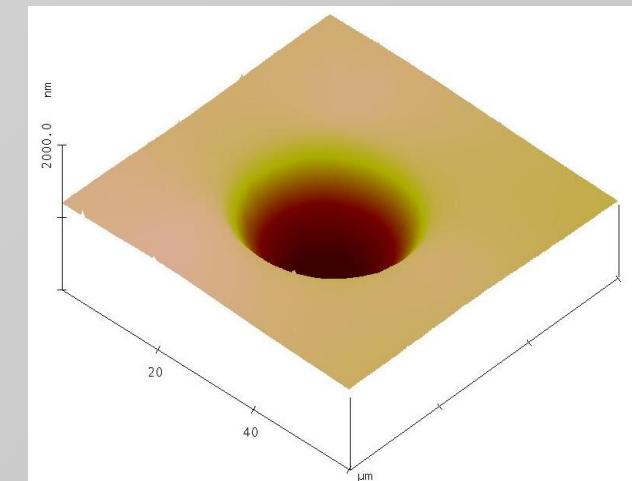
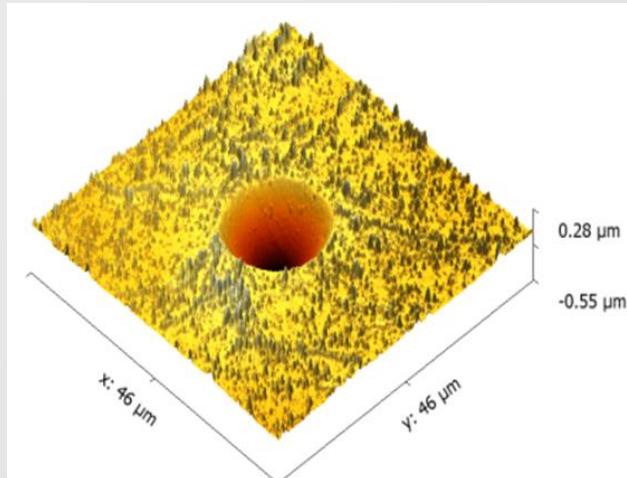
Fitting the unloading data
can make a big difference
to calculated values

Pile-up and Sink-in





Taljat & Pharr, International Journal of Solids and Structures 41 (2004) 3891–3904



Pile-up:

Push up of plastic material around indent
Real contact area larger than measured

Pile-up: under-estimates contact area

Actual $a = 3.95 \mu\text{m}$

Measured $a = 3.45 \mu\text{m}$, A 24% too small

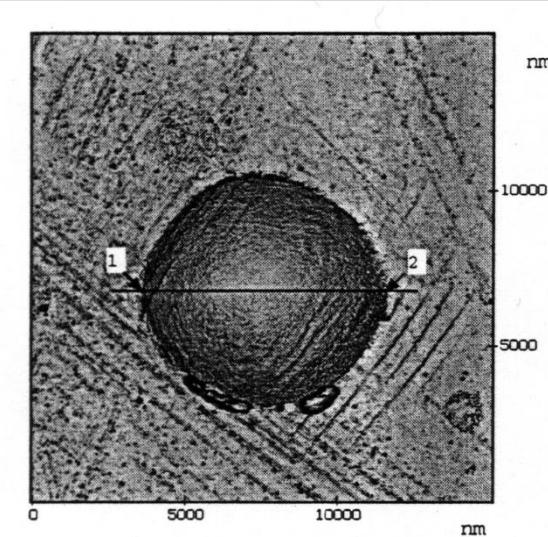
$$H \propto 1/A \propto 1/a^2$$

H increased by 31% !

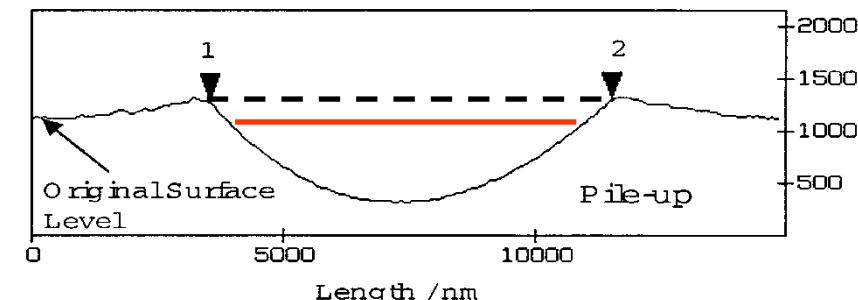
$$E \propto 1/\sqrt{A} \propto 1/a$$

E increased by 14%

(a)



(b)



Example for work hardened copper
(perfectly plastic – material does not flow away)

Sink-in:

Depression of plastic material around indent
Real contact area smaller than measured

Sink-in: over-estimates contact area

Actual $a = 2.33 \mu\text{m}$

Measured $a = 2.73 \mu\text{m}$, A 37% too big

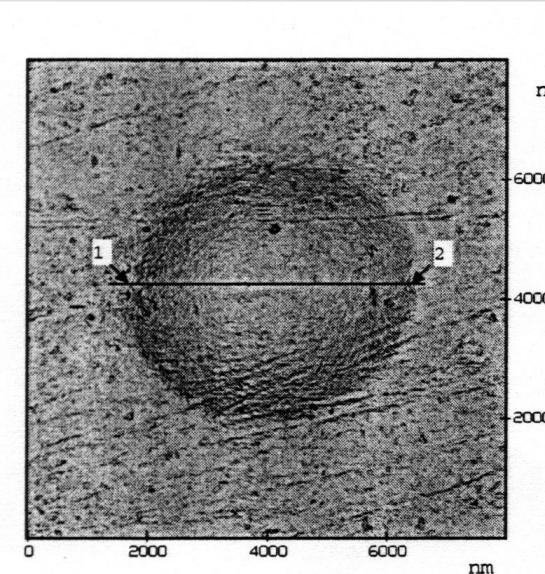
$$H \propto 1/A \propto 1/a^2$$

H reduced by 27% !

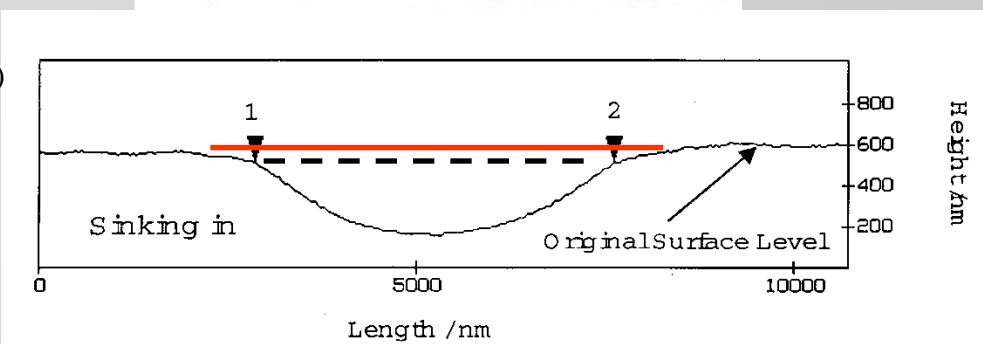
$$E \propto 1/\sqrt{A} \propto 1/a$$

E reduced by 14%

(a)

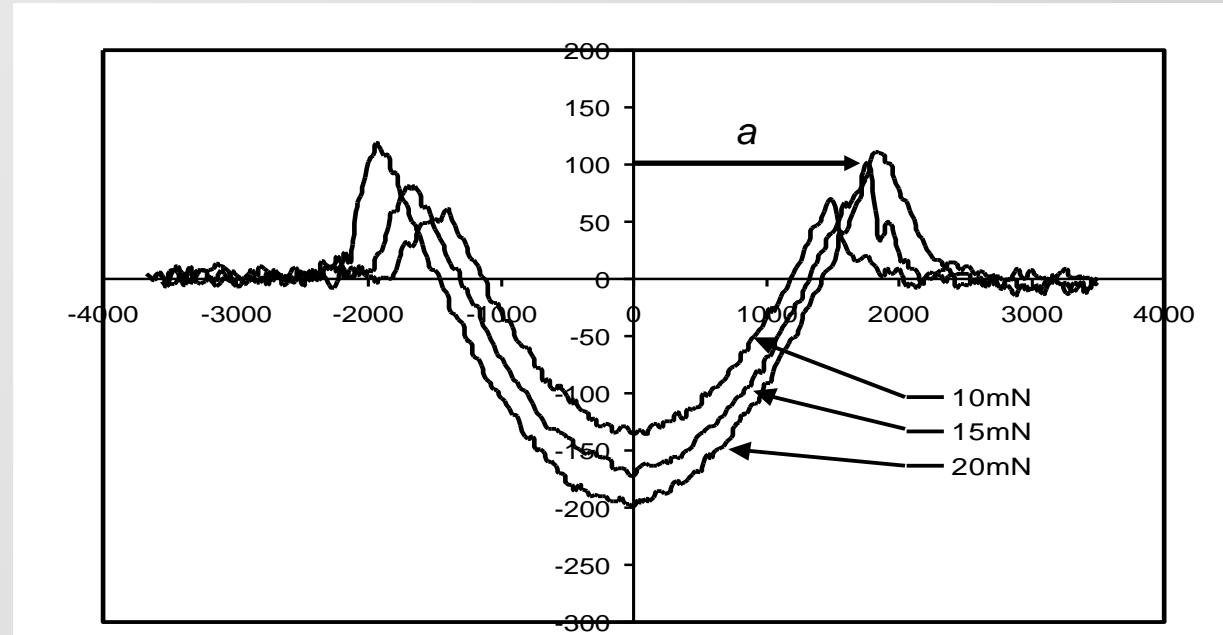


(b)



Example for annealed copper
(work hardens rapidly)

Development of pile-up with increasing load



Measured contact radius, a , by metrological AFM

Nominal indenter radius = $5\mu\text{m}$
Aluminium

Potential pitfalls

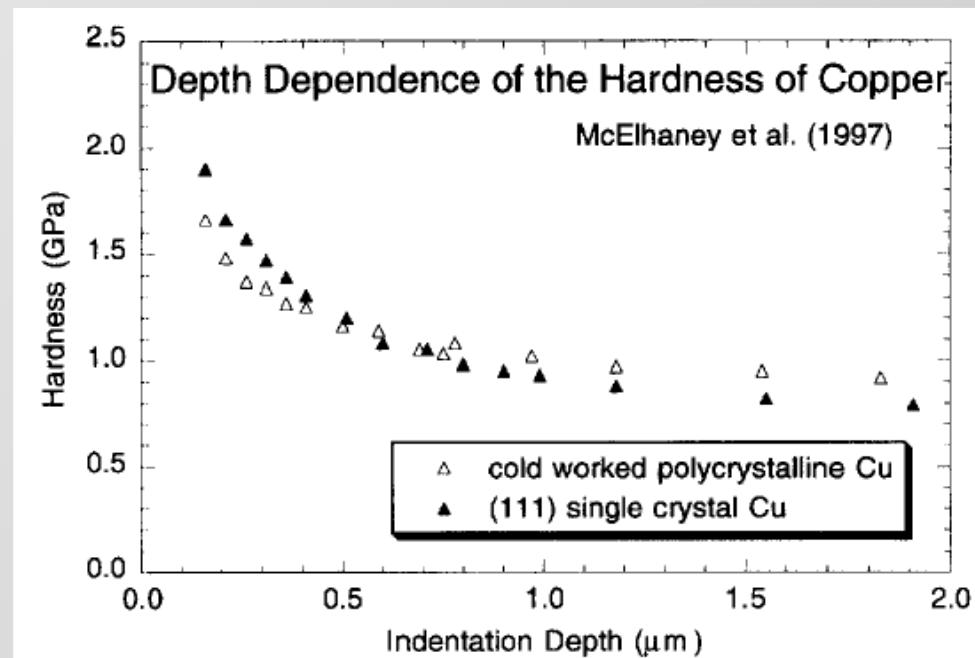
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- **Size effects (changes in material properties with scale)**

Elastic modulus and hardness are expected to be material constants i.e. independent of size

Elastic modulus **is** the most constant (and characteristic) materials properties

Hardness shows a 'size effect'

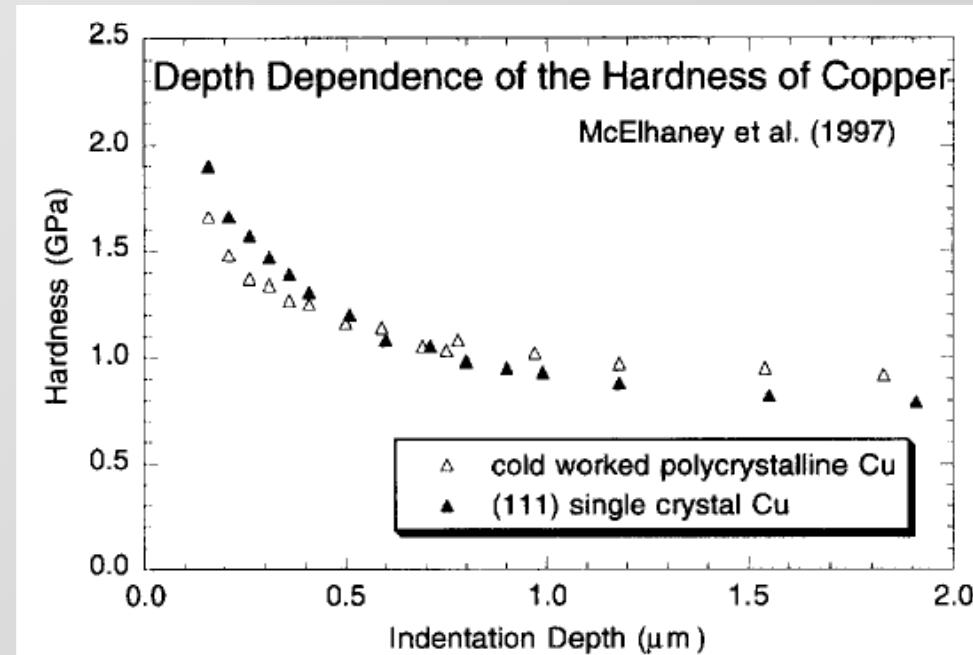
smaller = harder



Indentation size effects are not always easy to recognize

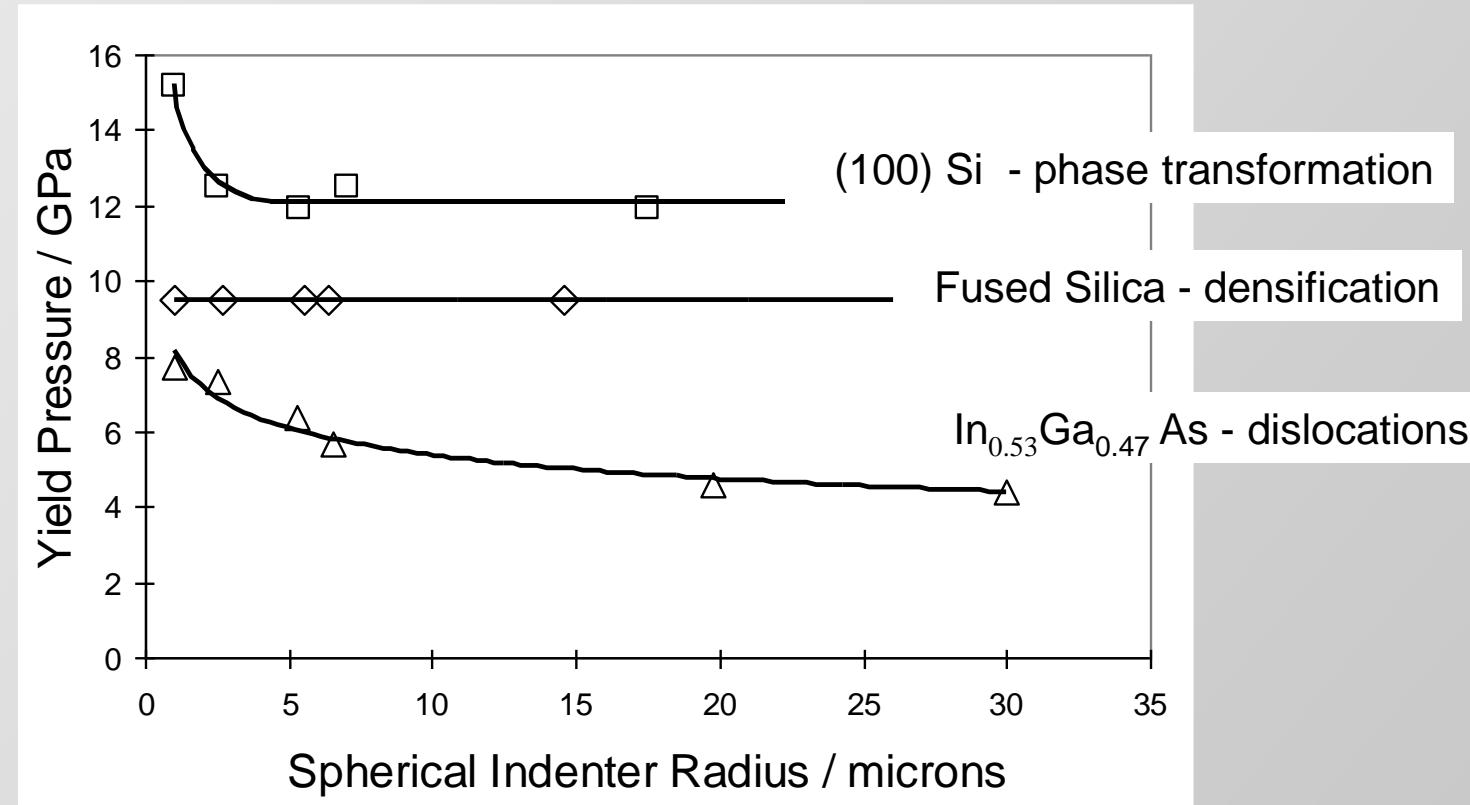
Single crystals show the size effect most clearly

For strong materials (e.g. ceramics or fined grain sized metals)
the size effect is only recognizable in very small indentations – near surface

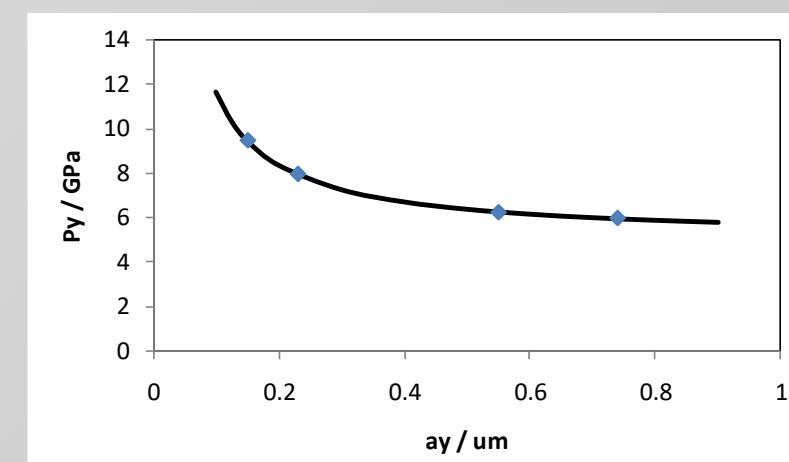
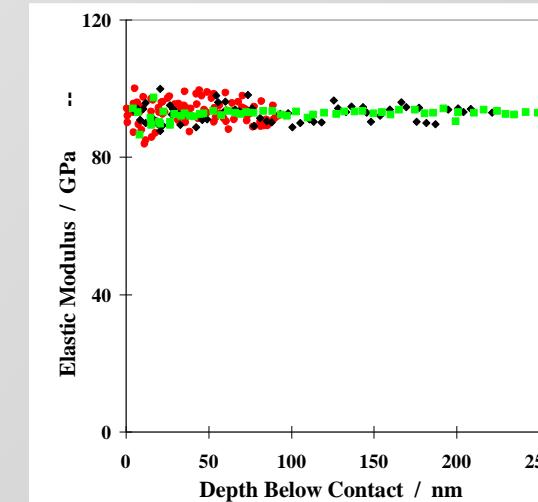
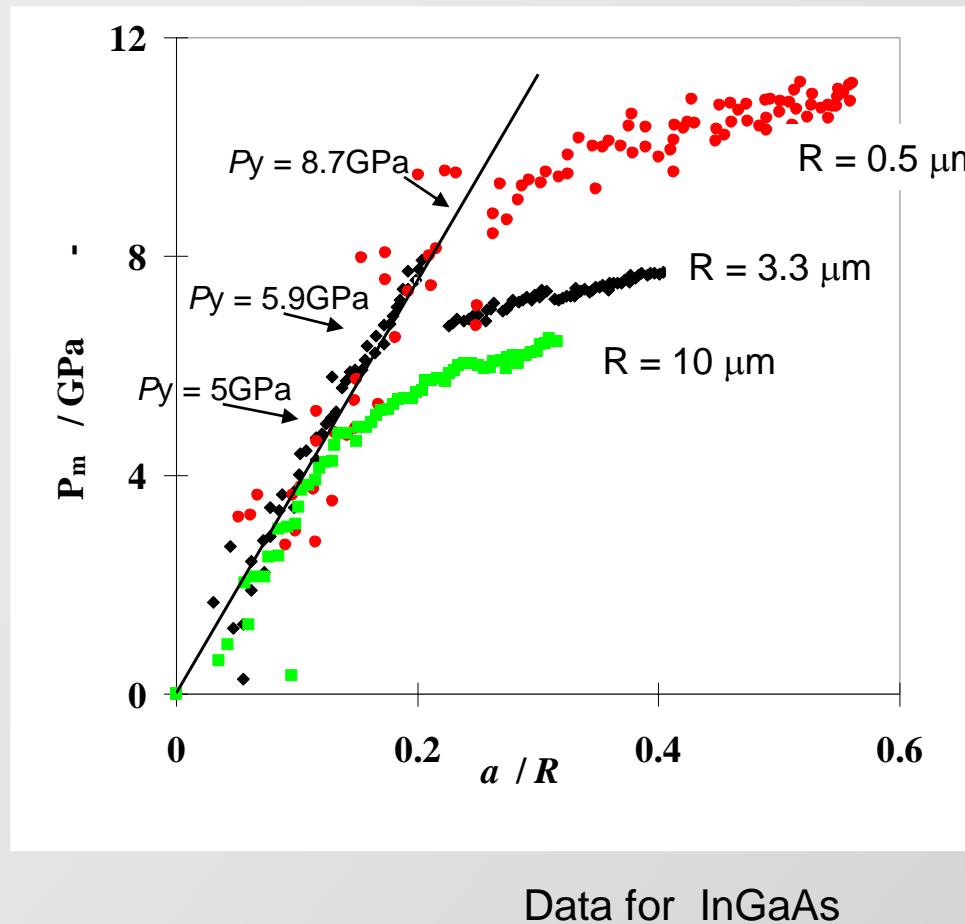


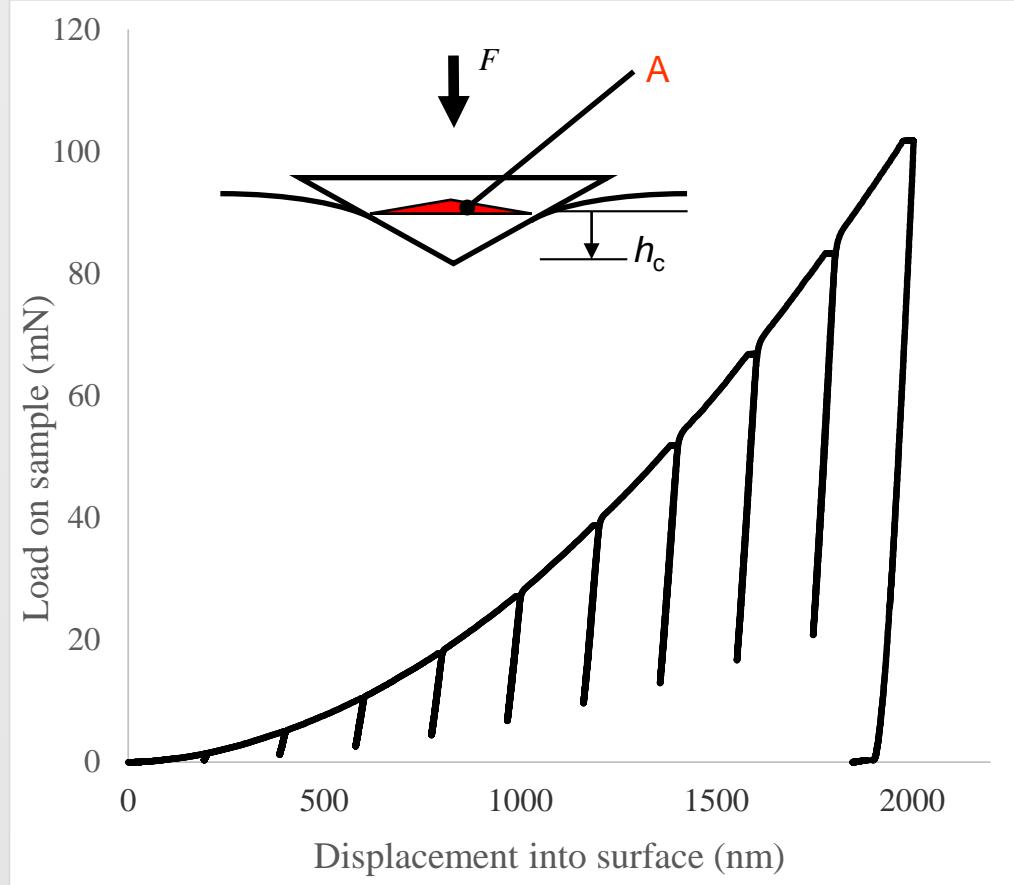
Size effect depends on the mechanisms of plastic relaxation

Strongest in crystalline materials that deform by dislocation plasticity



Higher yield pressure (stress) for smaller radius indenter but constant E



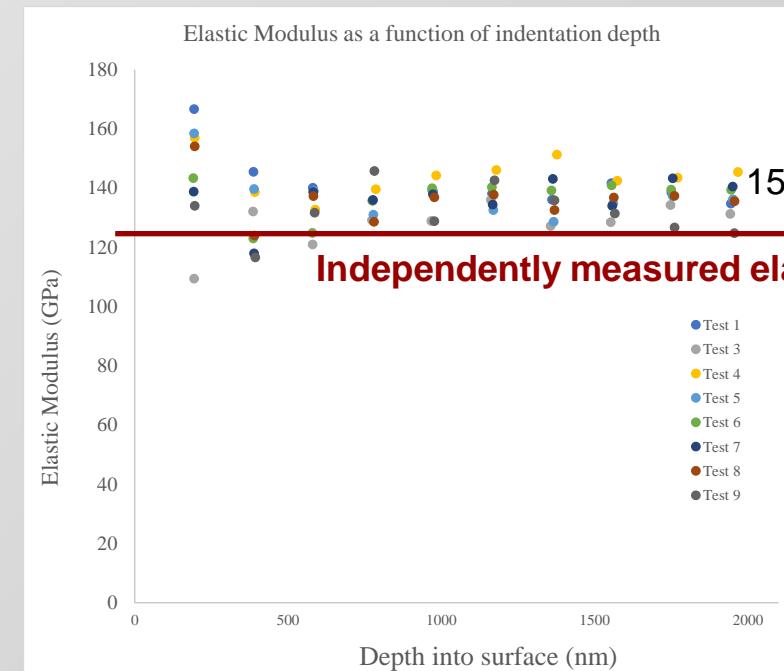
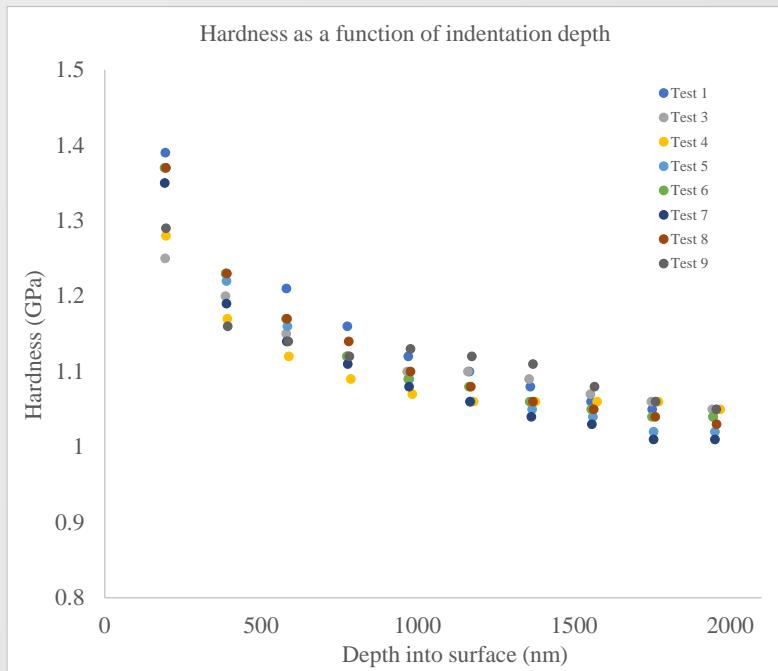


- **Berkovich indenter**
- Multi-cycle test
- 10 depths per test (total displacement)
up to $2\mu\text{m}$ depth
- Partially unload to 25% of each max load
- O&P analysis of each partial unload curve

- No pause for creep
- $h_c \neq h_{\max}$
- Repeatability at different locations

Need calculated contact areas at each depth

Berkovitch indenter – different depths in a multi-cycle test



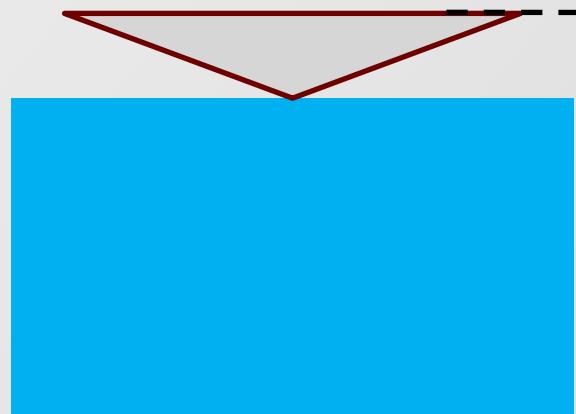
Error in H due to pile-up

E overestimated by 15% due to pile-up

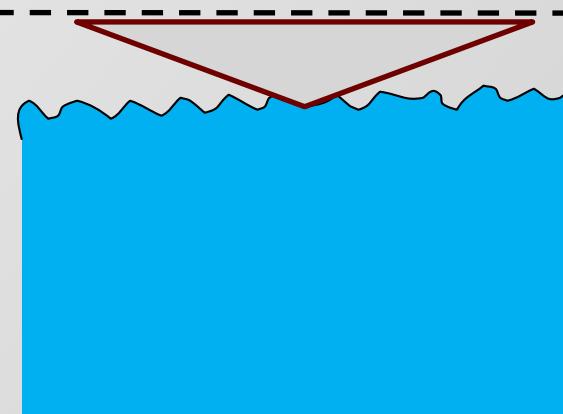
Modulus not constant with depth:

- Apparent size effect in modulus due to contact detection error caused by surface roughness?

e.g.



Tip calibration – reference sample



Sample measurement

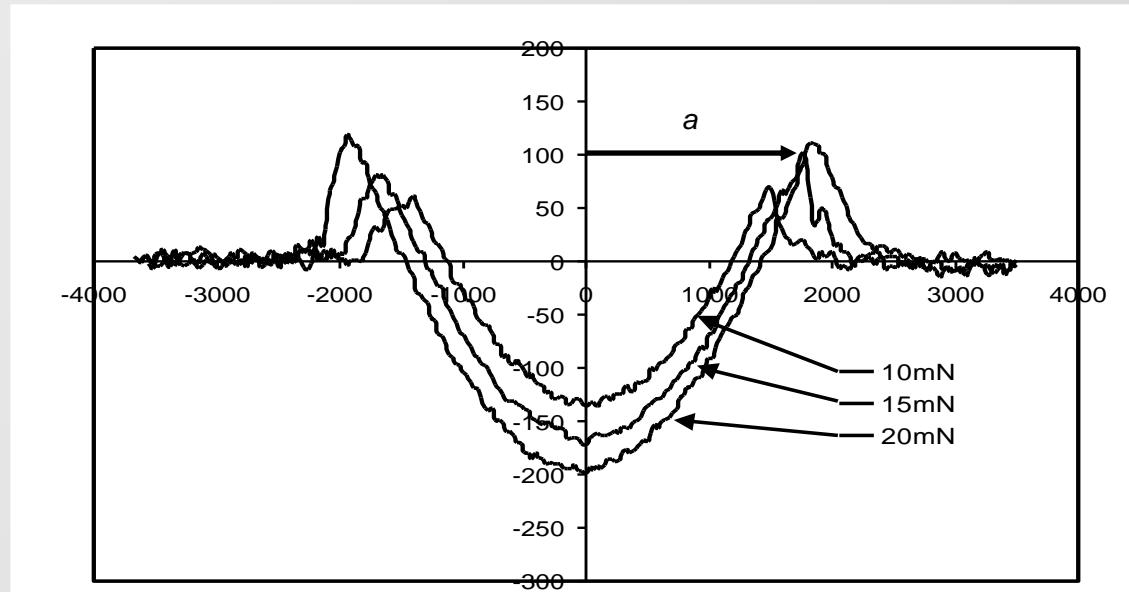
Error in apparent contact depth
Hence area function

Diminishes with increasing
contact depth

Modulus increased compared to expected value:

- Apparent over estimate of elastic modulus due to pile-up caused by plasticity

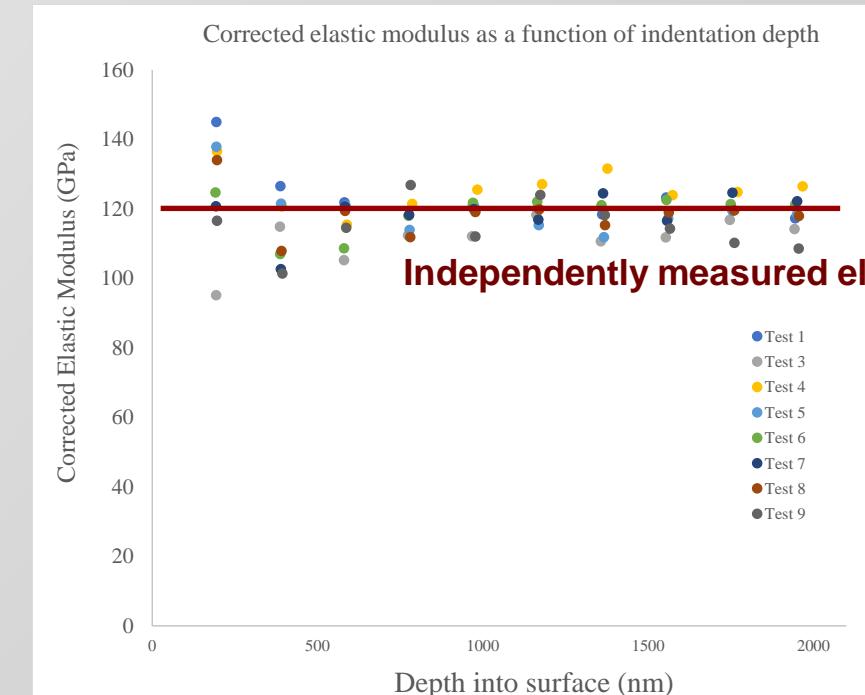
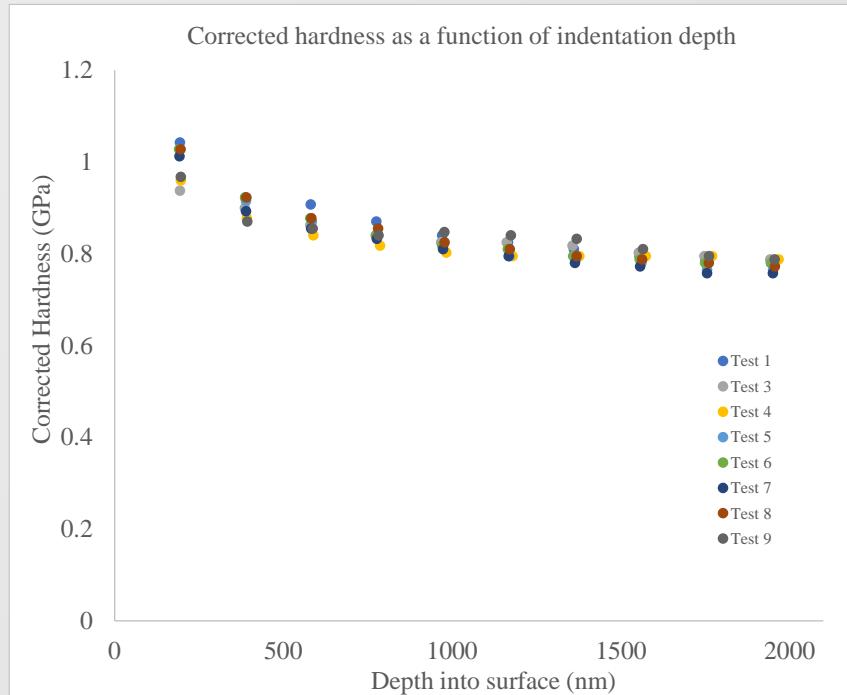
e.g. Measurement of true contact area by AFM – post-test



Estimate of true contact area, a

If direct measurement not possible –
Estimate correction from an independent
value for elastic modulus

Berkovitch indenter – different depths in a multi-cycle test – corrected for contact area (from modulus)



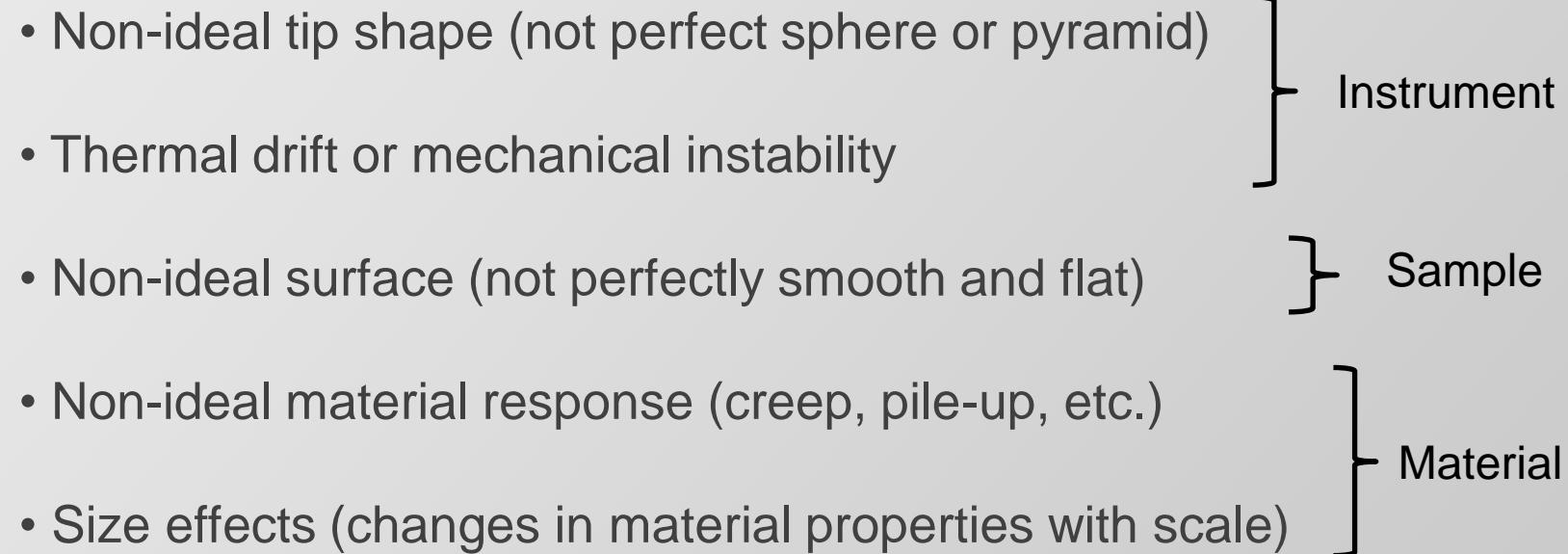
H corrected for estimated contact area error
Project H value to macro-scale



Using the known elastic modulus to estimate
the error in contact area A

Potential pitfalls

- Non-ideal tip shape (not perfect sphere or pyramid)
- Thermal drift or mechanical instability
- Non-ideal surface (not perfectly smooth and flat)
- Non-ideal material response (creep, pile-up, etc.)
- Size effects (changes in material properties with scale)



The diagram illustrates the classification of potential pitfalls. Three large curly braces on the right side of the list group the items into three categories: 'Instrument', 'Sample', and 'Material'. The 'Instrument' category includes the first two items. The 'Sample' category includes the third item. The 'Material' category includes the last two items.